

**UNIVERSITY OF MINNESOTA**

# **OPDK User Manual**

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**Wei Zhang  
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**Contact VLSI Group @ University of Minnesota**

Contact VLSI Group @ University of Minnesota by:

Telephone: (612) – 626 – 0834

Fax: (612)-626-4583

VLSI Group, ECE Department, University of Minnesota

Keller Hall (EECS Building), 4-168

200 Union Street SE

Minneapolis, MN 55455

**Questions & Comments**

Contact author (Wei Zhang) by:

Email: *zhang758@umn.edu*

# Using This Manual

This manual describes the Organic Process Design Kit (OPDK) and how to use it.

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## Audience

This manual is intended for designers who use OPDK to develop, test, analyze and modify organic circuit designs in ion-gel gated OTFT technique, and designers who develop device descriptions as an extension for other specific organic transistor structures.

## Related Documents

The following documents pertain to this manual:

- OPDK Features
- OPDK Release Notes

## Conventions

OPDK User Manual uses the following conventions, unless otherwise specified.

Convention	Description
<i>menuName -&gt; commandName</i>	Indicates the name of the menu and the command name. For example, <i>File -&gt; Save as</i> refers to the “ <i>Save as</i> ” command in the “ <i>File</i> ” menu.
<i>times italic</i>	Indicates commands, functions, arguments, file names and variables with a line of text.
<>	When a variable is included in italicized text, the variable is enclosed by angle brackets (<>). For example, “ <i>setenv OPDK_DIR/&lt;your_absolute_local_path&gt;/OPDK</i> ”, where <i>&lt;your_absolute_local_path&gt;</i> is your absolute local path of your OPDK directory.

## Other Sources of Information

The OPDK external website provides information for OPDK updates, downloads and documentation. The website can be accessed at <http://opdk.umn.edu>.

## Acknowledgement

The author would like to thank:

1. NCSU-FreePDK45 Developer Team (North Carolina State University and Oklahoma State University) for providing software framework for OPDK development.  
NCSU-FreePDK45 Website: <http://www.eda.ncsu.edu/wiki/FreePDK>
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## **Chapter 1**

### **Introducing OPDK**

This chapter introduces basic background of the Organic Process Design Kit (OPDK).

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Introducing Organic Thin-Film-Transistor (OTFT)

The Organic Process Design Kit (OPDK) – Definition and Purpose

The Organic Process Design Kit (OPDK) – Features

## Introducing Organic Thin-Film-Transistor (OTFT)

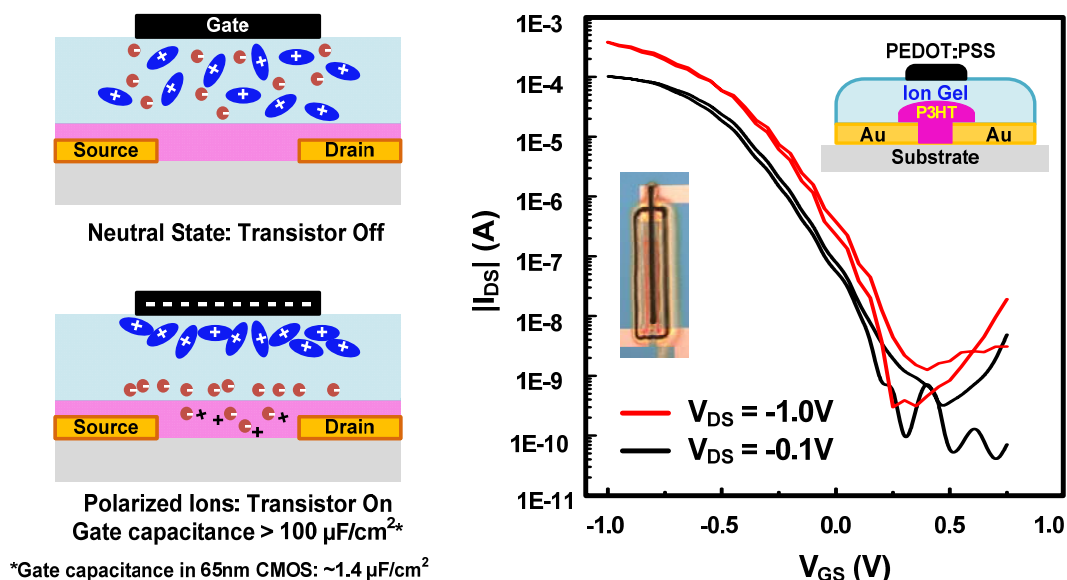
The integration of electronics onto the flexible substrate, including plastic and metal foils, will greatly expand the application area of microelectronics. However, difficulties have been encountered with the traditional silicon transistors, mainly due to their rigid lattice structure and the high temperature during fabrication. Organic thin-film transistors [1], which are composed of polymers, have been demonstrated to be a potential solution. Furthermore, the feasibility of printing organic transistors also indicates the perspective of low-cost fabrication.

Organic transistors, however, usually suffer from low carrier mobility, resulting in a high operation voltage. Few attempts have been made on printable, low-voltage organic transistors. Here we demonstrate a printable gel-OTFT technique which provides sufficient current under a low operation voltage (1V). A gel-OTFT is an organic thin-film transistor which is fabricated based on ion-gel, wherein ion-gel refers to an electrolyte formed by gelation of a triblock copolymer in an ionic liquid, acting as the gate dielectric.

Figure 1.1 shows the basic structure and mechanism of a gel-OTFT and its current-voltage characteristics [1]. Poly(3-hexylthiophene) (P3HT) is printed between the two gold electrodes (source and drain) as the channel layer. An ion-gel layer covers the entire channel layer and a conducting polymer poly(3,4-ethylenedioxythiophene) : poly(styrenesulfonate) (PEDOT:PSS) is printed on the top as the gate electrode. When the gate is floating, the ions in the ion gel are randomly distributed and the entire gel displays a neutral state. When the gate is biased with a negative voltage, the ions are polarized by the electrical field and interfaces are formed near both surfaces of ion gel, creating two capacitors in serial. If a voltage difference is also applied between the source and the drain, carriers in the channel layer will start to flow, leading to a drain current. Since the distance between charges at each interface is quite small (at the order of nm),



the equivalent gate capacitance is significantly high ( $\sim 100 \text{ uF/cm}^2$ ), which is around 70 times larger than that in the silicon transistors ( $\sim 1.4 \text{ uF/cm}^2$ ) [2]. Therefore, in spite of the relatively low carrier mobility, the large gate capacitance enables the transistor to generate a considerable current under a low operation voltage.



**Fig. 1.1** (a) Operation of ion-gel electrolyte transistor in off-mode and on-mode. The polarized ions enable an unusually high gate capacitance inducing large channel current. (b)  $I_{DS}$ - $V_{GS}$  curve shows a 0.4mA drive current at a 1 V supply voltage ( $W=500\mu\text{m}$ ,  $L=25\mu\text{m}$ ).

The detailed current-voltage characteristic curve is shown in Figure 1.1(b). Under a low voltage (1V), a transistor with  $W/L = 500\mu\text{m}/25\mu\text{m}$  achieves 0.4mA drain current, which is sufficient in most applications. Another important aspect is the on/off ratio of the transistor, which is the ratio between drain currents under  $V_{GS} = -1\text{V}$  and  $V_{GS} = 0\text{V}$ . It can be noted that the on/off ratio is as high as 1000, which is good enough for digital applications. These data illustrate the feasibility of fabricating high-performance and stable low-voltage digital circuits with gel-OTFTs.

The gel-OTFT demonstrated above is a p-type transistor with P3HT channel layer. N-type transistor is also possible in this technique if suitable N-type channel material is available. However, the introduction of a viable n-type material has been delayed due to unstable

characteristics, no good contact, and significantly lower mobility than their p-type counterpart. Therefore, n-type device is not the focus of Organic Process Design Kit (OPDK) at the current stage.

In conclusion, we have demonstrated our printable gel-OTFT technique, where the high gate capacitance caused by polarized ions is the key to generating significant current under a low operation voltage. The current-voltage characteristics have shown the great potential of gel-OTFTs in achieving stable digital applications.

References:

- [1] Y. Xia, W. Zhang, M. Ha, et al., "Printed Sub-2 V Gel-Electrolyte-Gated Polymer Transistors and Circuits", *Applied Functional Materials*, Volume 20, Issue 4, pages 587–594, February 22, 2010.
- [2] W. Zhang, M. Ha, D. Braga, M. Renn, C.D. Frisbie, C.H. Kim, "A 1V Printed Organic DRAM Cell Based on Ion-Gel Gated Transistors with a Sub-10nW-per-Cell Refresh Power", *International Solid-State Circuits Conference (ISSCC)*, February 2011

## **The Organic Process Design Kit (OPDK) – Definition and Purpose**

The main purpose of OPDK is to facilitate the entire OTFT circuit system design. The earlier OTFT designs rely on examinations by naked eyes and lack effective verification in either functionality or layout. To ensure reasonable yield for complex circuit systems, it is required to improve the design tools and introduce verification steps.

Fortunately, sharing a lot in common with silicon transistors, especially in the structure, OTFTs are able to adapt similar techniques widely used in silicon industry. For example, among the mainstream computer-aided-design (CAD) software, Cadence Virtuoso© design environment is feasible to be utilized for OTFTs both for designing circuits and drawing layouts. Circuit simulation software such as HSPICE© is also an excellent candidate to verify the design functionality.

The existing tools, however, cannot be directly utilized since the major characteristics and materials are totally different. Therefore, OPDK, the design kit specifically developed for OTFTs, targets at building a software package based on silicon transistors while following the real properties of OTFT. With the help of Cadence Virtuoso and HSPICE, it enables computer-based verifications on circuit and layout designs, and significantly reduces design load for large-scale systems.

## **The Organic Process Design Kit (OPDK) – Features**

OPDK is a design kit developed for OTFT platform under the software environment of Cadence Virtuoso. It has the following major features:

1. Supports circuit design in Cadence environment;
2. Supports layout design in Cadence environment;
3. Supports major built-in tools in Cadence environment;
4. Supports circuit file generation through Cadence Virtuoso Analog Design Environment;
5. Supports design rule checks (DRC) for layouts;
6. Supports layout versus schematic (LVS) checks for layouts;
7. Supports all layers currently used in the OTFT platform, with other layers for future extension;
8. Supports two kinds of OTFT devices (ion-gel-top-gated OTFTs with P3HT or CNT channel layer);
9. Supports resistor with three unit resistance options;
10. Supports capacitor based on ion-gel-top-gated OTFT with P3HT channel layer;
11. Provides P-Cells for the two kinds of OTFT devices and for capacitor;
12. Provides HSPICE device models to perform functionality verification;
13. Provides examples of inverter, NAND, DFF, DRAM, etc.
14. Extensible for other types of organic devices, including N-type devices

## **Chapter 2**

# **Getting Started**

This chapter provides the basic steps of using OPDK. For details, you may refer to Chapter 3-6.

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System Requirement

Setup OPDK

Example: Design of an Inverter with Top-Gated P3HT-Channel TFT

Example: Layout of an Inverter with Top-Gated P3HT-Channel TFT

## **Before You Start – System Requirements**

To run all features Organic Process Design Kit (OPDK) in Cadence, please first make sure you have met the following system requirement:

1. Cadence Virtuoso, version 6.1.1 or higher.
2. Mentor Calibre 2006.4 (OA 2.2.5) or higher

Running OPDK with a lower version of Cadence or Mentor is not tested and may require changes in configuration. If you are not sure about your system environment, please contact your IT support.

## 1. Setup OPDK

1.1 Make a new directory called OPDK under your home directory:

```
mkdir OPDK
```

1.2 Go to OPDK:

```
cd OPDK
```

1.3 Copy the file OPDK-1.5.tar to directory OPDK by using the command from this directory:

```
cp OPDK-1.5.tar.gz .
```

1.4 Extract the archive using the command

```
tar -zxvf OPDK-1.5.tar.gz
```

1.5 You should now be able to see the extracted files under OPDK at your home directory. This contains an open-source, open-access based OPDK for organic electronic applications based on ion-gel technology from the Department of Chemical Engineering and Materials Science (CEMS) at the University of Minnesota, Twin Cities.

1.6 Go to `organic_basekit/cdssetup` under OPDK directory

```
cd organic_basekit/cdssetup
```

Here, you will have to modify `setup.csh` using `vi`, `nano` or any of your favorite editors as follows:

1.6.1 Comment out the line which defines the environment variable `OPDK_DIR` (it starts with "setenv").

Lines can be commented out by adding a `#` at the beginning.

1.6.2 Set the `OPDK_DIR` variable to the root directory of the OPDK distribution

```
setenv OPDK_DIR <your_absolute_local_path>/OPDK
```

1.6.3 Comment out the line which defines the environment variable CDSHOME.

1.6.4 Set the CDSHOME variable to the root directory the Cadence installation. For example:

```
setenv CDSHOME /home/apps/common/cadence/Linux/ic_611/tools.lnx86/
```

1.6.5 Save and exit the file. Your OPDK is setup and ready to be used now.

1.7 Create your temporary Cadence work directory at OPDK

```
cd OPDK/
```

```
mkdir cds
```

```
cd cds
```

Always run Cadence from this directory to avoid cluttering up your workspace.

1.8 Copy setup.csh (the file you modified in step 1.6) into this directory

```
cp ../organic_basekit/cdssetup/setup.csh .
```

Source this script using the following command

```
source setup.csh
```

This script copies the files needed by Cadence and initializes the environment.

1.9 Invoke Cadence by typing:

```
virtuoso &
```

This should bring up the command interface window and library manager. You are now ready to design circuits in Cadence.



## **2. Example: Design of an Inverter with Top-Gated P3HT-**

### **Channel TFT**

This example will help you familiarize yourself with OPDK in Cadence. This will show the most important commands and steps used when working with schematics in Cadence. As an example, you will design a simple inverter with resistor load. For details of the various components, please refer to the next few chapters.

Before starting with the design example, there are a couple things worth mentioning:

- Most of the commands in Cadence can be accessed in multiple ways: pull-down menus, shortcut keys, buttons in toolbars, etc. In the described example, all the commands are referenced by their position in the pull-down menus. The shortcut keys can be found from the pull-down menus as well.
- The most frequently used key in Cadence is ESC. It is used to cancel on-going commands.

The following picture shows the schematic of an inverter, which is ready for netlist extraction.

The following section explains how to draw it in Cadence.

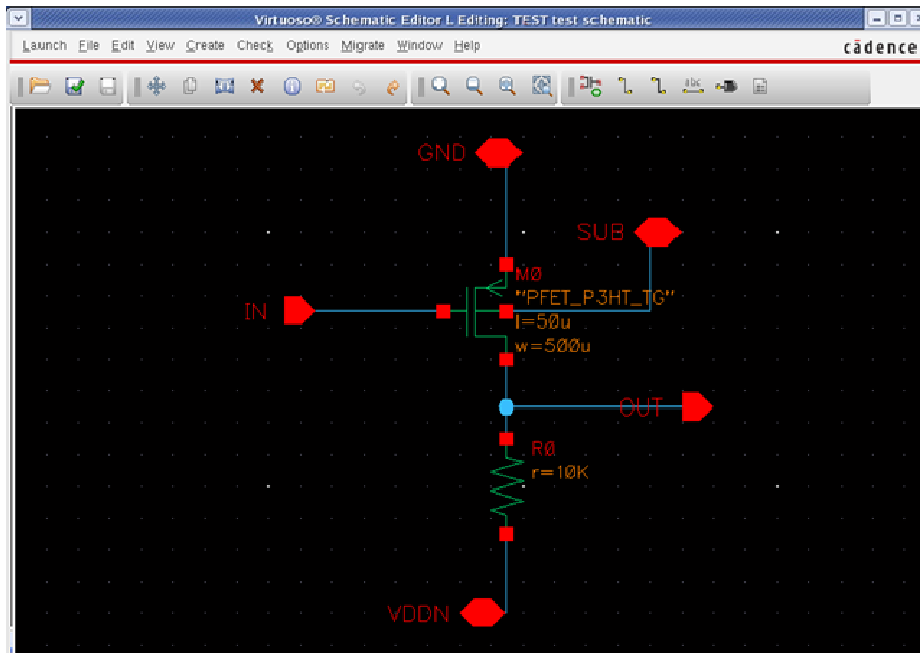


Fig. 2.2.1 Schematic of an inverter

## 2.1 Create a library for your new design

From the library manager window:

*File->New->Library*

Type a new name, such as TEST, click OK.

In the pop-up window, choose “Attach to an existing tech library”.

Then, choose “OPDK\_TechLib”). Click OK.

## 2.2 Create a new cell

In the Library Manager, highlight your new library (TEST if that is what you chose).

*File->New->Cellview*

Choose library TEST, cell name “inverter”, view name “schematic”, and Open with “Schematic L”. Click OK.

Click “Always” if “Upgrade License” warning message shows up.

A schematic window will open.

## 2.3 Design your circuit

### 2.3.1 Place components

For this inverter, you will need a top-gated P3HT-channel TFT and a resistor.

From Schematic window,

*Create->Instance*

*Add Instance* and *Library Browser* windows will open. If the *Library Browser* window does not open automatically, simply click Browse on the *Add Instance* window. Make sure the Library in the *Library Browser* is set to *OPDK\_Devices*. Use the *Library Browser* window and click on *PTFT\_P3HT\_TG*, then select *symbol* and close the window.

In the *Add Instance* window, type in the appropriate width and length values. Here we use width= 500um and length=50um. Place the PTFT in the schematic window.

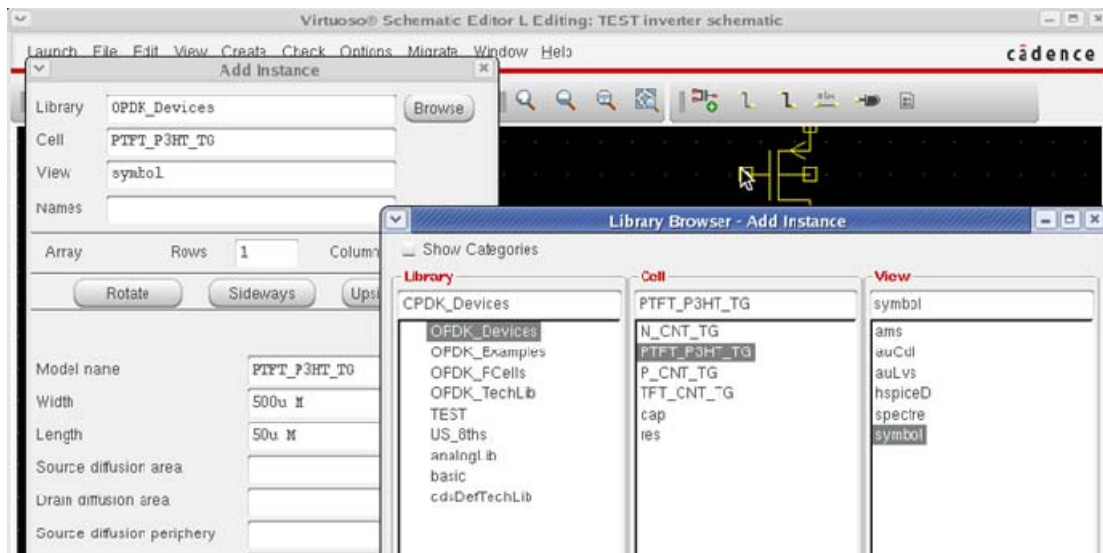


Fig. 2.2.2 Add a P3HT-OTFT device symbol into schematic

Similarly, place a resistor of 10K Ohm with the “res” symbol.

If you make any mistake, you can always use:

*Edit->Delete* *or*

*Edit->Rotate* *or*

*Edit->Move* *or*

*Edit->Stretch*

To change the properties of some of the components:

*Edit->Properties->Objects*

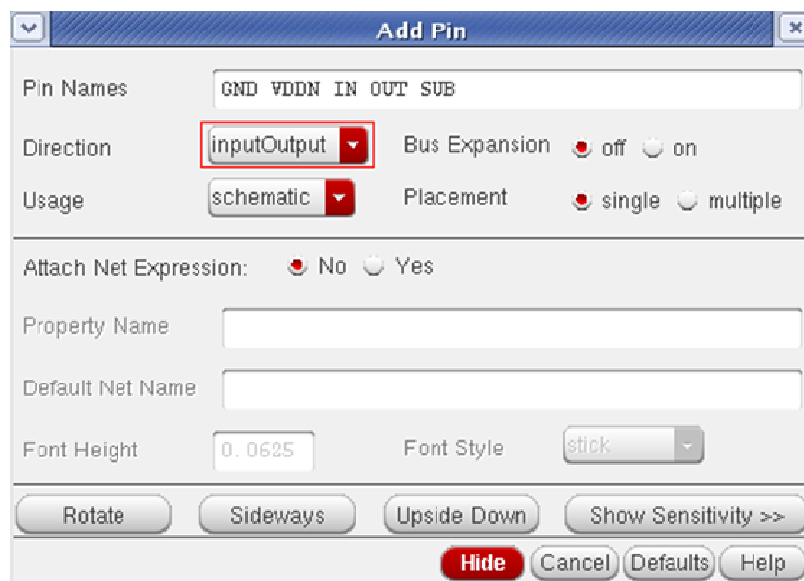
### **2.3.2 Place pins**

For this inverter, you will need five pins: ground (GND), negative power (VDDN), input (IN), output (OUT) and substrate (SUB).

From Schematic window,

*Create->Pin*

*Add Pin* window will open. Type in the pin names and place the pins in the appropriate locations. Pay attention to the red box shown below, and make sure you choose the right I/O direction for each pin. For example, IN should be Input, OUT should be Output, and all the rest should be InputOutput.



**Fig. 2.2.3 Specify pin names and types**

### 2.3.3 Connect components

Connect the component terminals as shown in the figure above using:

*Create->Wire (narrow)*

### 2.4 Generate netlist files

In the Schematic Window:

*Design->Check and Save*

There should be no errors. Then go *Launch->ADE L*.

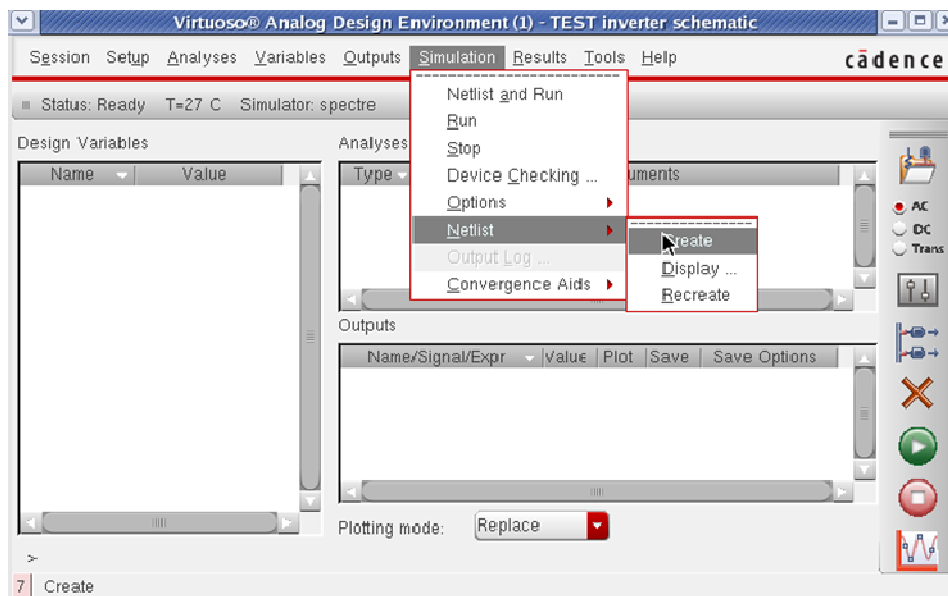
The window of Cadence Analog Design Environment will show up.

Make sure the current simulator is set to hspiced:

*Setup->Simulator/Directory/Host*

Set the simulator to hspiced.

*Simulation->Netlist->Create*



**Fig. 2.2.4 Create netlist from schematic view**

A new window will pop up showing the generated HSPICE netlist. You may save this file by clicking the menu bar:

*File->Save As*

Specify the full path name and file name in the *Save As* window. If you have models ready, you can use this netlist file to run simulations with the model. You may need to modify some of the netlist, which we will not discuss in details.

## **2.5 Working with symbols**

If you want to use your design in other schematics, you need to create a symbol for it. This is equivalent to the use of sub-circuits in HSPICE. Using hierarchy in your project makes it easier to organize.

### **2.5.1 Create a new symbol**

Save the schematic before you create its symbol:

*File->Check and Save*

*Create->Cellview->From Cellview*, click OK.

A new window will open with the symbol view. By default, the symbol shape is a rectangle, but you can change it. Since this design is an inverter, we will draw a triangle and put a small circle at the output. To do this, you will want to delete the green rectangle, draw the new shape, and move the terminals to new positions. Use *Create->Shape* to draw a triangle and place a circle. There are several shapes available: line, rectangle, circle, etc.

You will also need to change the Selection box (the red rectangle), which defines the limits of the symbol. This can be done by stretching the Selection box. Figure below shows an example of the inverter symbol:

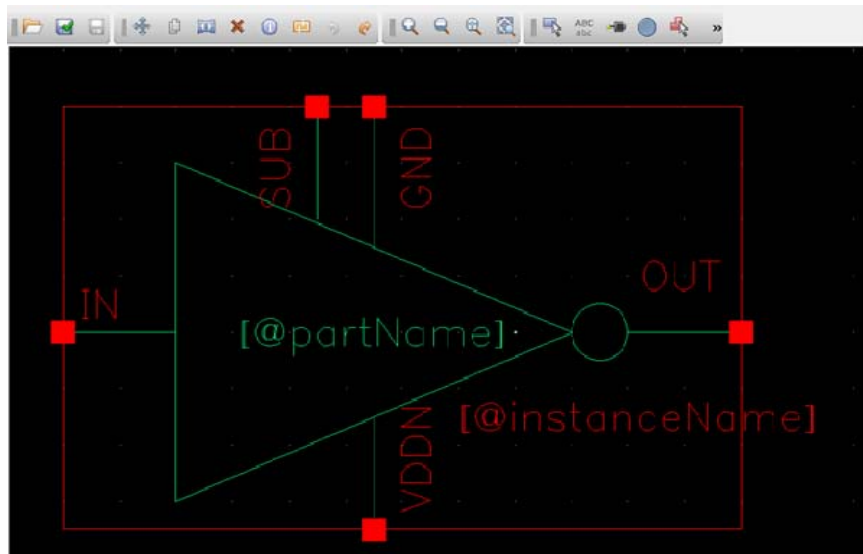


Fig. 2.2.5 Create symbol from schematic view

Don't forget to check and save.

### 2.5.2 Use the symbol in other schematics

Create a new schematic, using the instructions described in [Create a new cell](#). Give a name such as *test\_inverter*.

You place this symbol in the new schematic in the same way that you placed any other components, with:

*Create->Instance*

This time change the Library to your library TEST and click on *inverter*. Your symbol should be here.

To move in the hierarchy, select the inverter, and then:

*Edit->Hierarchy->Descend Edit.*

You can choose the schematic or the symbol for editing.

To return to the previous schematic, use:

*Edit->Hierarchy->Return*

### 3. Example: Layout of an Inverter with Top-Gated P3HT-Channel TFT

This example will help you to create a layout for the inverter you designed in the first example. The following picture shows a layout for the inverter. The following sections explain how to make each of the separate components in Virtuoso.

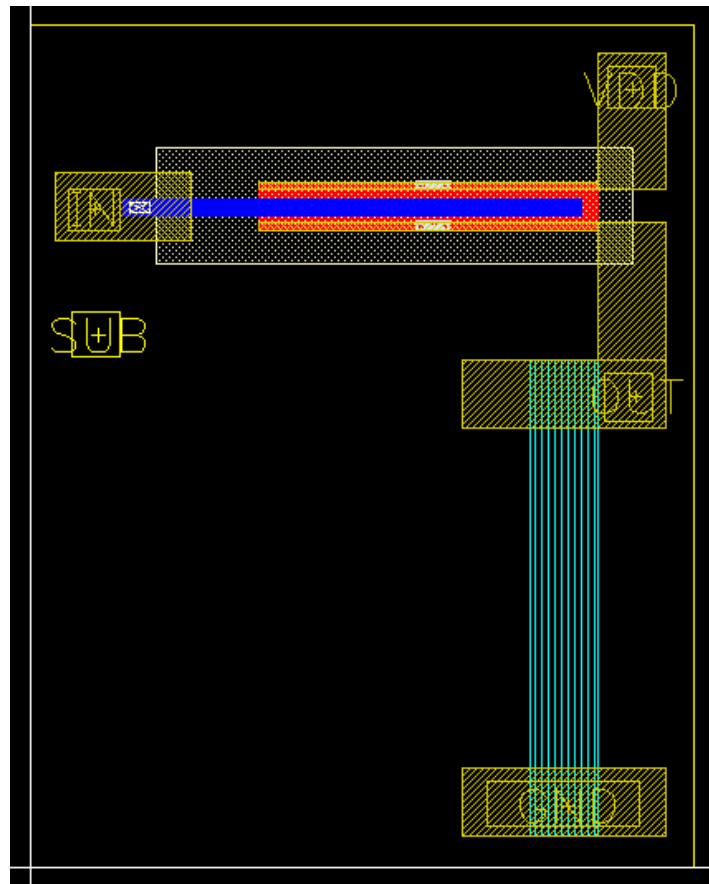


Fig. 2.3.1 Layout of an inverter

#### 3.1 Create a layout view of your cell

In the Library Manager, Highlight your inverter schematic library (TEST if that is what you chose).

*File -> New -> Cellview*



Change the view type to layout and open with layout L. Click OK. Click “Always” if there is any license upgrade message.

A layout-editing and an LSW window will open up.

### **3.2 Layout the components for your circuit**

For this inverter we will need to layout a Top-gated P3HT-channel PTFT and a resistor.

#### **3.2.1 Layout a PTFT**

For better illustration, it is recommended to draw different layers in the order of how it is actually fabricated.



#### **A. METAL1**

In the LSW window, choose METAL1 (drw). From the Layout window, choose

*Create->Shape->Rectangle*

1. Draw the source/drain electrodes. Assume we are going to draw a PTFT with  $W/L = 500\mu\text{m}/50\mu\text{m}$ , with a source/drain electrode width of  $10\mu\text{m}$ . Draw a rectangle of  $500\mu\text{m} \times 10\mu\text{m}$ , and draw another one under the first rectangle, with  $50\mu\text{m}$  distance in between.

2. Draw the source/drain connections to other nets. On the right side of the drawn electrodes, draw two rectangles in METAL1, each being  $100\mu\text{m} \times 200\mu\text{m}$ .

3. Draw the gate electrode. On the left side of the drawn electrodes, draw a rectangle of  $100\mu\text{m} \times 200\mu\text{m}$  in METAL1,

with  $100\mu\text{m}$  distance away from the source/drain electrodes.

The final pattern should look like this:

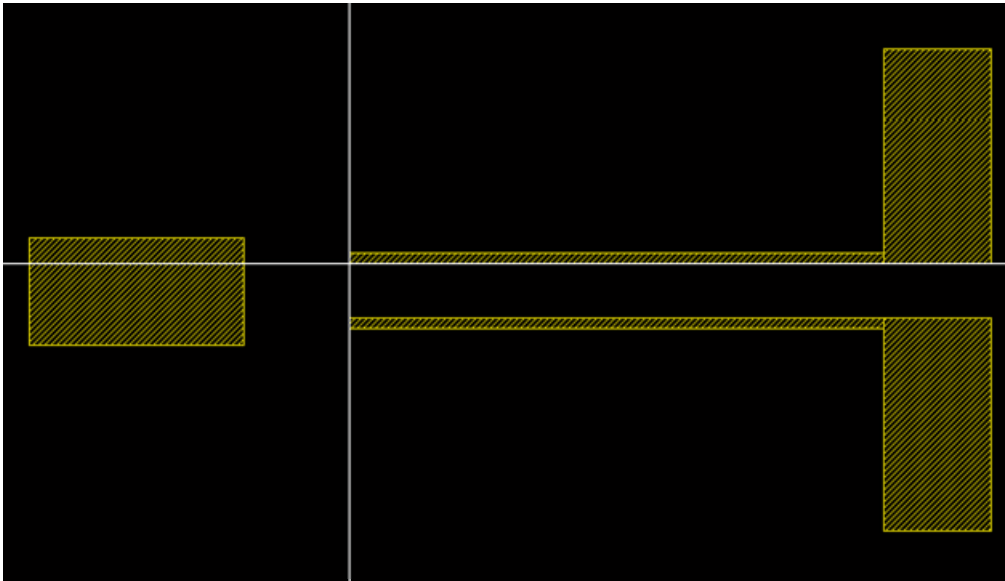


Fig. 2.3.3 Metal pattern of a P3HT-OTFT

#### B. P3HT Channel

Select P3HT\_TFT (drw) from LSW window, and draw a rectangle of 500um x 120um, covering the entire two source/drain electrodes and filling the entire 50um gap to form a channel.

#### C. Ion-Gel Dielectric

Select IONGEL\_TFT (drw) from LSW window, and draw a rectangle of 700um x 120um, completely enclosing the P3HT channel, with 25um extension on the length direction and 50um extension on the width side onto METAL1.

#### D. PEDOT Conductive Layer

Select PEDOT\_TFT (drw) from LSW window, and draw a rectangle of 675um x 25um, placed roughly in the middle of the channel. Locate the rectangle so that it extends onto METAL1 over Iongel layer on the gate side by 50um. Iongel layer should also enclose this PEDOT layer by 25um on the right side.

**E. Contact**

For LVS purpose, dummy contacts are required in layout. Select COTFT (drw) from LSW window and draw rectangles at source (P3HT overlapping METAL1) and drain (P3HT overlapping METAL1). Select CONTACT (drw) from LSW window for rectangles at gate (PEDOT overlapping METAL1 but not interacting with IONGEL).

**F. Substrate**

For LVS purpose, substrate layer is required in layout. Select SUB (drw) from LSW window and draw a rectangle to enclose everything.

The final layout should look like this:

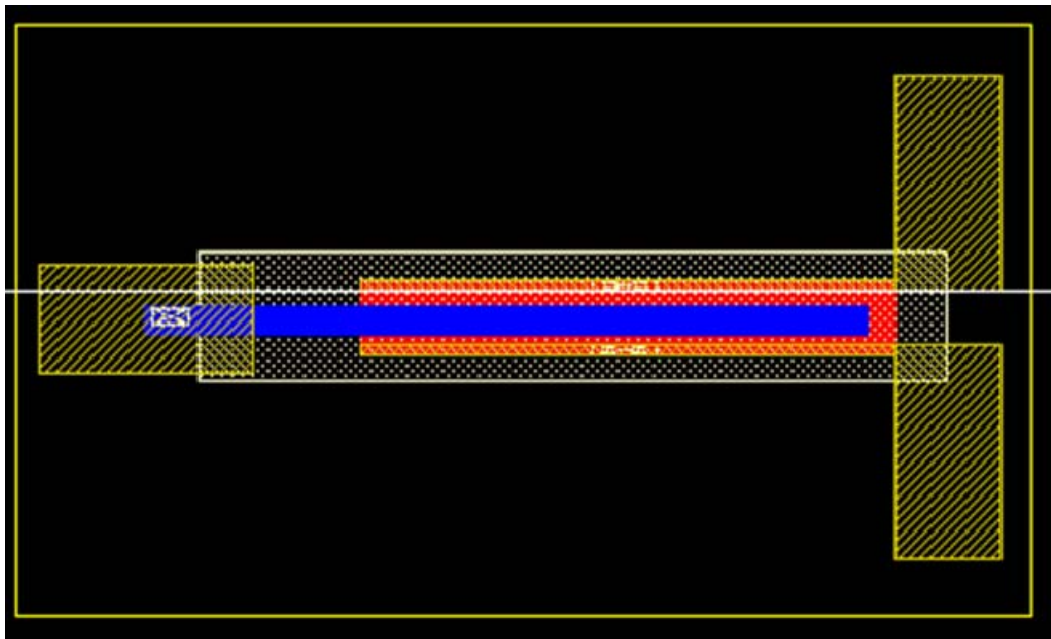


Fig. 2.3.4 Final layout of a P3HT-OTFT

**3.2.2 Layout a resistor****A. METAL1**

OPDK provides three types of resistor layers: PEDOT\_R2K, PEDOT\_R10K and PEDOT\_R100K. The resistor value is calculated by  $L/W * R\_Unit$ , where R\_Unit value is the suffix of each type of layer.

Assume we are going to draw a 10K resistor with PEDOT\_R2K. L/W ratio should be 5 according to the calculation. So here we can go with width=100um and length=500um.

Select METAL1 from LSW window, and draw two rectangles of 300um x 100um, being 500um away from each other in Y-direction.

**B. Resistor**

Select PEDOT\_R2K (drw) from LSW window and draw a rectangle of 100um x 700um, extending onto METAL1 layers by 100um each.

**C. Substrate**

Select SUB (drw) from LSW window and draw a rectangle to enclose everything, or simply stretch the previous SUB.

The final layout should look like this:

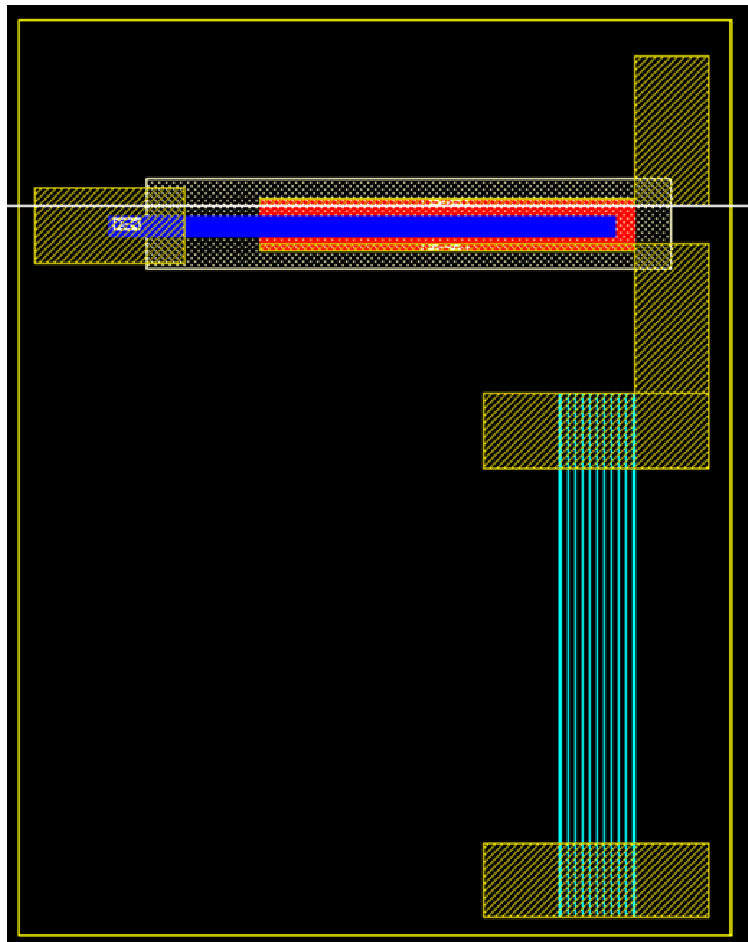


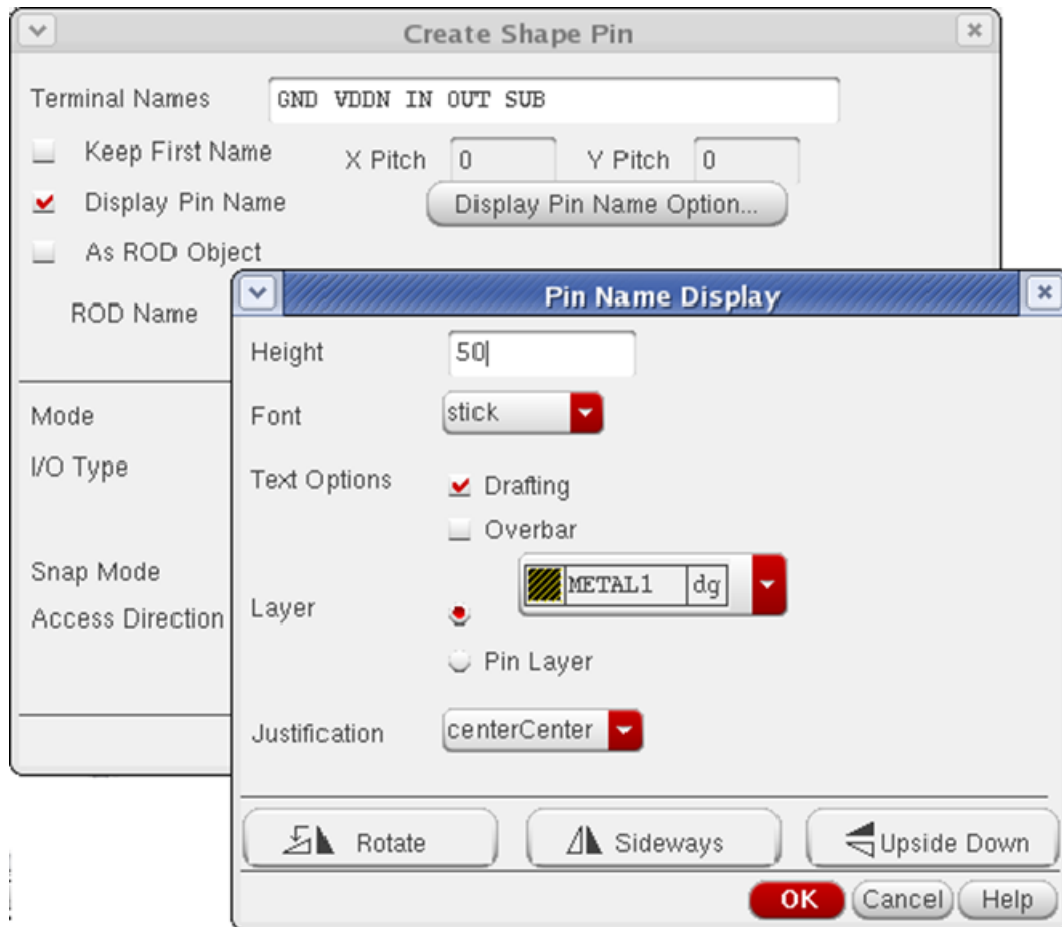
Fig. 2.3.5 Final layout of an inverter w/o pins

### 3.2.3 Add pins

For LVS purpose, pins are required in layout.

*Create -> Pin*

A Create Pin window will open.



**Fig. 2.3.6 Add pins**

Type in the pin names and check “Display Pin Name”. Click “Display Pin Name Option” and a Pin Name Display window opens. Set the text height to 50, and set appropriate layer for the pins. In this example, SUB should be of SUB (drawing) layer while all the rest should be of METAL1 (drawing) layer. Do not close the windows before you finish your drawing.

Go back to the layout view, and select the appropriate layer (METAL1 drawing) in the LSW window for the first pin you will place (GND). Draw a rectangle on the metal plate of ground, and place the text on or near it. You can do the rest in the same way.

**Note:** Do not use “Create-Rectangle” to draw the pins. The “Create-Pin” command automatically provides rectangle drawings.

**Note:** Be sure to change the layer for SUB.

The final layout should be look like the one shown in the beginning of this section.

### **3.3 Route**

If in the future you need to route between different instances or cells, simply use METAL1 for connection.

### **3.4 Grid control for layout**

In the layout view, the mouse pointer only snaps to a certain spacing of location. The spacing can be set by:

*Options->Display*

In the Grid Control panel, the “X Snap Spacing” and “Y Snap Spacing” control the resolution of mouse snap in layout. In default, “X Snap Spacing” and “Y Snap Spacing” are set to 1 $\mu$ m. You should **either keep the default setting or change them to multiples of 1 $\mu$ m** in your layout because in this design kit, DRC rule requires the edge of the drawing (e.g. rectangle wire) lies on a grid which is a multiple of 1 $\mu$ m.

### **3.4 Perform DRC Verification**

It's always a good practice to stop and do a DRC check from time to time before placing more components to your diagram. To do so, clicking on:

*Calibre->Run DRC...*

A window that looks like the one below opens up. Set the *DRC Rules File* to: \$OPDK\_DIR/organic\_basekit/techfile/calibre/calibreDRC.rul and *DRC Run Directory* to: \$OPDK\_DIR/runcalibre.

Click on *Run DRC* and the DRC will now run.

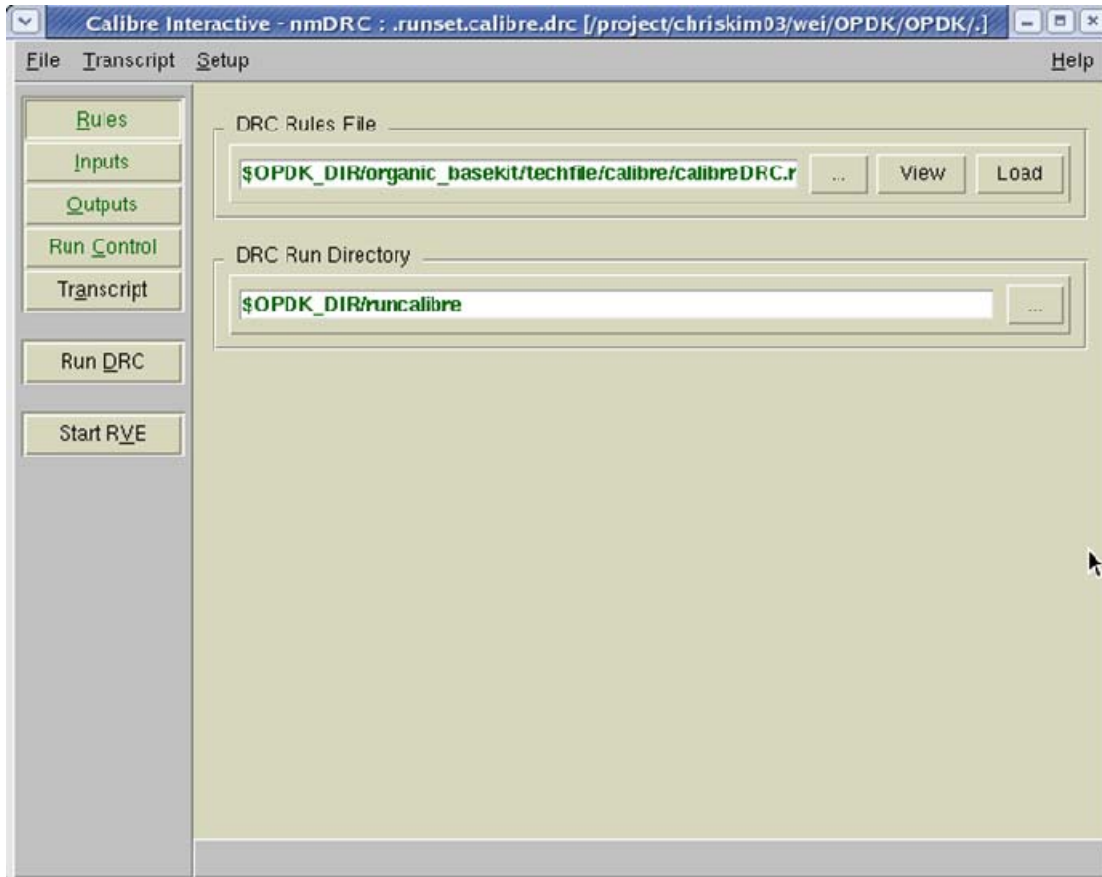
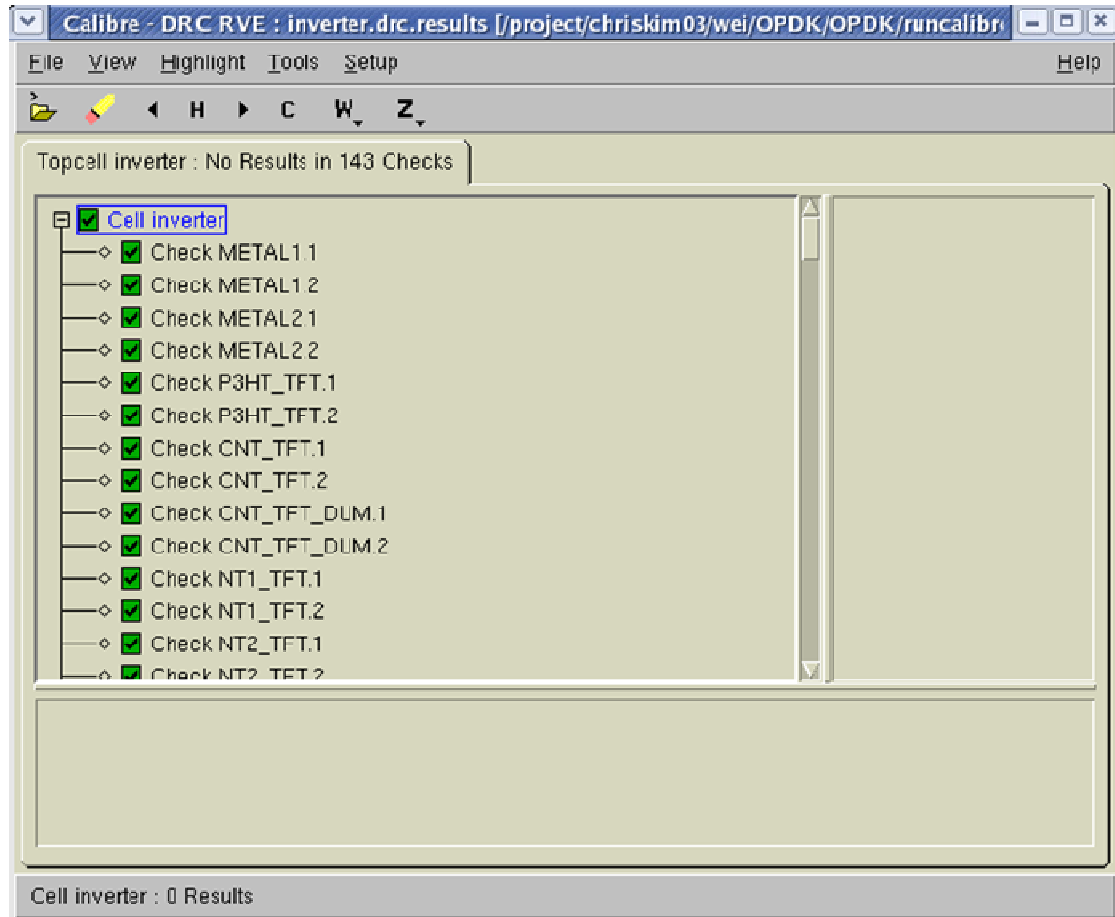


Fig. 2.3.7 Calibre DRC interface



If everything is okay, it should finish with this popped-out window:



**Fig. 2.3.7 Calibre DRC check results**

If there are errors, the message will contain statistics about which rules were violated. To see why and where you violate the DRC rule, double click on the error messages and the corresponding layers or boundaries will be highlighted in the layout. To understand the details of the DRC rules, please visit the website of OPDK.

### **3.5 Perform LVS Verification**

The LVS tool is used to compare the layout with the schematic, identifying any circuit related differences that might exist between these two views. It reports circuit nodes and

device sizes. It is a very useful tool since it helps us identify wrong connections or shorts or open-circuits that may be difficult to be discovered by naked eyes.

To perform LVS verification, click on:

*Calibre -> Run LVS...*

The LVS dialog window opens up. Again, set the *LVS Rules File* to: \$OPDK\_DIR/organic\_basekit/techfile/calibre/calibreLVS.rul and *LVS Run Directory* to: \$OPDK\_DIR/runcalibre. Go to “Inputs” and make sure for both Layout and Netlist, “Export from layout (or schematic) viewer” is checked. Click on *Run LVS* and the LVS will now run.

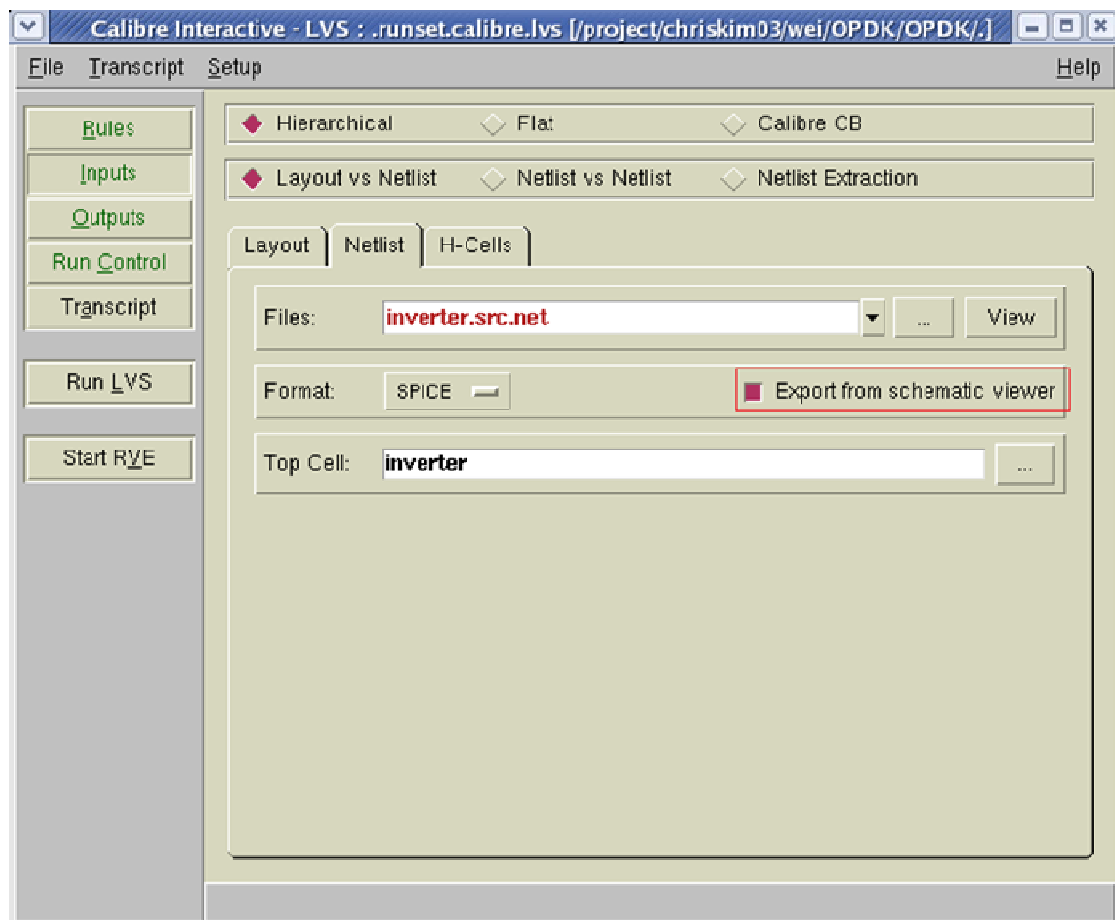
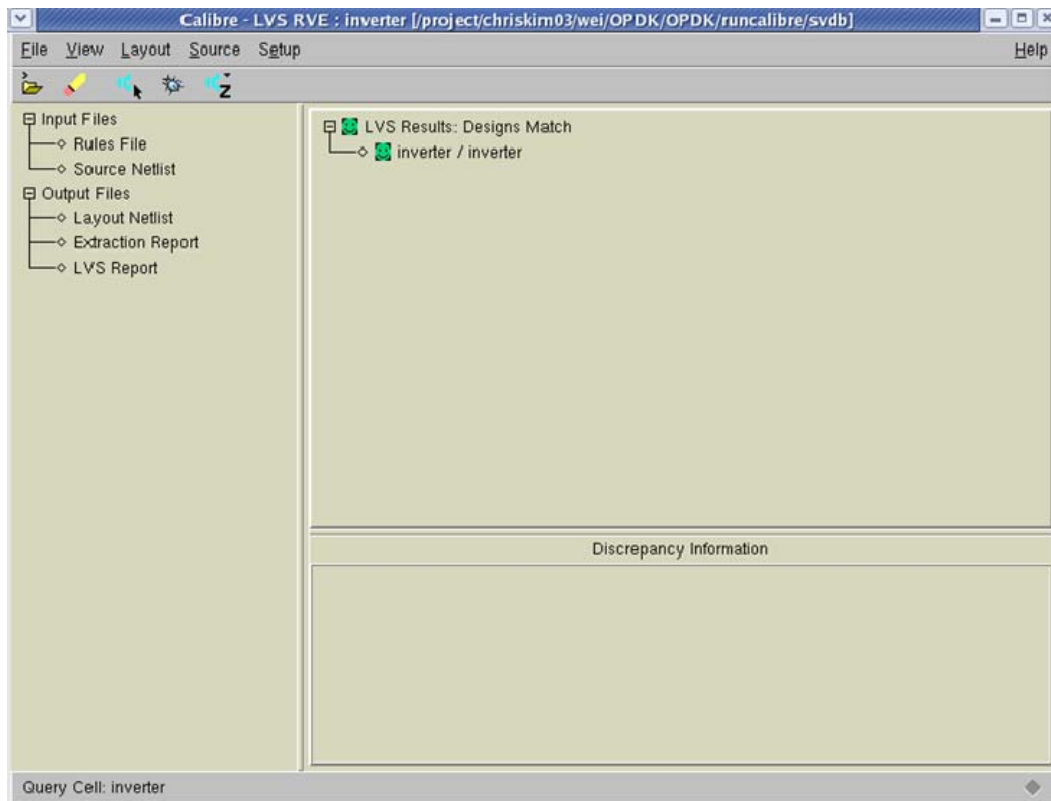


Fig. 2.3.8 Calibre LVS interface

If everything is okay, it should finish with this popped-out window:



**Fig. 2.3.9 Calibre LVS check results**

If there are errors, the message will contain statistics about what kind of errors are found. To see why and where you get an error, double click on the error messages and the corresponding layers or boundaries will be highlighted in the layout.

**Note:** Sometimes you may have multiple labels with the same name, e.g. “GND” on a few separated GND rails. If they are eventually going to be connected, while you want to leave them separated at the moment, you should go to *Setup->LVS Options* and enable *LVS Options* menu, and check *Connect->Connect all nets by name*. This will automatically recognize all nets with the same name to be connected, even if they are not physically connected in your layout. So you need to be careful when using this option. Or

you can check *Connect->Connect nets* named and specify the net names to be connected during LVS.

## **Chapter 3**

### **Designing Layout of OTFT**

This chapter provides details about designing layouts for the supported OTFT devices.

---

Supported OTFT Devices

Layout of Ion-Gel-Top-Gated P3HT-Channel OTFT

Layout of Ion-Gel-Top-Gated CNT-Channel OTFT

## **1. Supported OTFT Devices**

The supported OTFT devices in this OPDK are based on ion-gel technique with a top-gated structure, provided by Dr. Frisbie's group in Chemical Engineering and Material Science Department at the University of Minnesota.

Two devices are supported:

OTFT with P3HT channel layer (p-type); and

OTFT with CNT channel layer (modeled as a p-type and a n-type device in parallel)

Corresponding device symbols:

OPDK\_Devices/PTFT\_P3HT\_TG/symbol

OPDK\_Devices/TFT\_CNT\_TG/symbol

## 2. Layout of the Ion-Gel-Top-Gated P3HT-Channel OTFT

### A. METAL1

In the LSW window, choose METAL1 (drw). From the Layout window, choose

*Create->Shape->Rectangle*

1. Draw the source/drain electrodes. Assume we are going to draw a PTFT with  $W/L = 500\mu\text{m}/50\mu\text{m}$ , with a source/drain electrode width of  $10\mu\text{m}$ . Draw a rectangle of  $500\mu\text{m} \times 10\mu\text{m}$ , and draw another one under the first rectangle, with  $50\mu\text{m}$  distance in between.
2. Draw the source/drain connections to other nets. On the right side of the drawn electrodes, draw two rectangles in METAL1, each being  $100\mu\text{m} \times 200\mu\text{m}$ .
3. Draw the gate electrode. On the left side of the drawn electrodes, draw a rectangle of  $200\mu\text{m} \times 100\mu\text{m}$  in METAL1, with  $100\mu\text{m}$  distance away from the source/drain electrodes.

The final pattern should look like this:

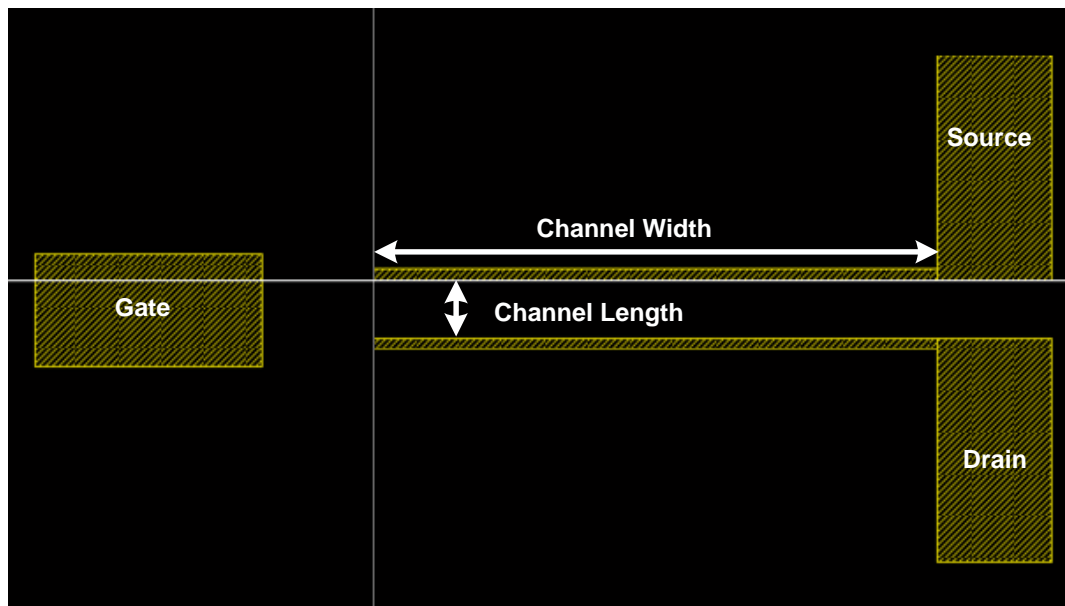


Fig. 3.2.1 Metal pattern of a P3HT-OTFT

**B. P3HT Channel**

Select P3HT\_TFT (drw) from LSW window, and draw a rectangle of 500um x 120um, covering the entire two source/drain electrodes and filling the entire 50um gap to form a channel.

**C. Ion-Gel Dielectric**

Select IONGEL\_TFT (drw) from LSW window, and draw a rectangle of 700um x 120um, completely enclosing the P3HT channel, with 25um extension on the length direction and 50um extension on the width side onto METAL1.

**D. PEDOT Conductive Layer**

Select PEDOT\_TFT (drw) from LSW window, and draw a rectangle of 675um x 25um, placed roughly in the middle of the channel. Locate the rectangle so that it extends onto METAL1 over Iongel layer on the gate side by 50um. Iongel layer should also enclose this PEDOT layer by 25um on the right side.

**E. Contact**

For LVS purpose, dummy contacts are required in layout. Select COTFT (drw) from LSW window and draw rectangles at source (P3HT overlapping METAL1) and drain (P3HT overlapping METAL1). Select CONTACT (drw) from LSW window for rectangles at gate (PEDOT overlapping METAL1 but not interacting with IONGEL).

**F. Substrate**

For LVS purpose, substrate layer is required in layout. Select SUB (drw) from LSW window and draw a rectangle to enclose everything.



The final layout should be like this:

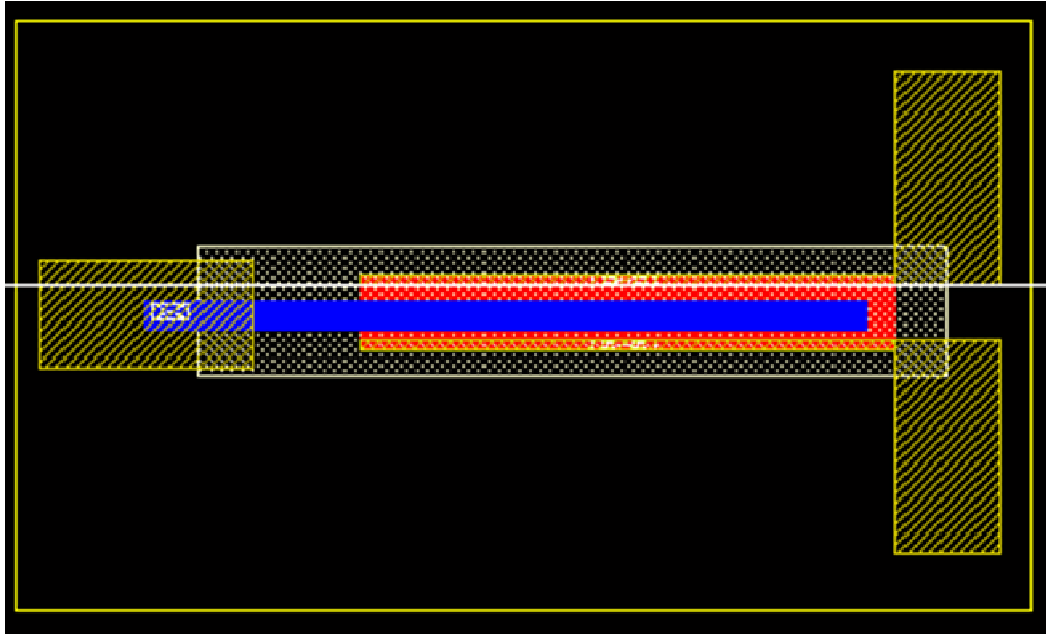


Fig. 3.2.2 Final layout of a P3HT-OTFT

### 3. Layout of the Ion-Gel-Top-Gated CNT-Channel OTFT

**Note:** CNT TFTs are neither P-type nor N-type. The corresponding device is modeled as a PTFT\_CNT\_TG and a NTFT\_CNT\_TG connected in parallel.

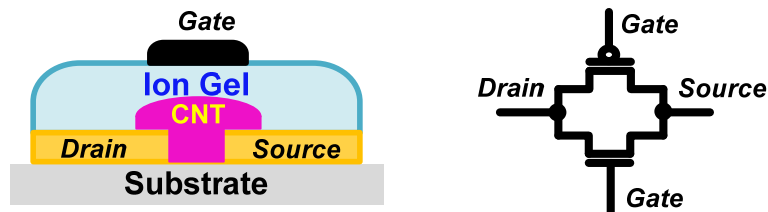


Fig. 3.3.1 Modeling illustration of a CNT-OTFT

#### A. METAL1

In the LSW window, choose METAL1 (drw). From the Layout window, choose

*Create->Shape->Rectangle*

1. Draw the source/drain electrodes. Assume we are going to draw a TFT with  $W/L = 500\mu\text{m}/50\mu\text{m}$ , with a source/drain electrode width of  $10\mu\text{m}$ . Draw a rectangle of  $500\mu\text{m} \times 10\mu\text{m}$ , and draw another under the first rectangle, with  $50\mu\text{m}$  distance in between.
2. Draw the source/drain connections to other nets. On the right side of the drawn electrodes, draw two rectangles in METAL1, each being  $100\mu\text{m} \times 200\mu\text{m}$ .
3. Draw the gate electrode. On the left side of the drawn electrodes, draw a rectangle of  $200\mu\text{m} \times 100\mu\text{m}$  in METAL1, with  $100\mu\text{m}$  distance away from the source/drain electrodes.

The final pattern should look like this:

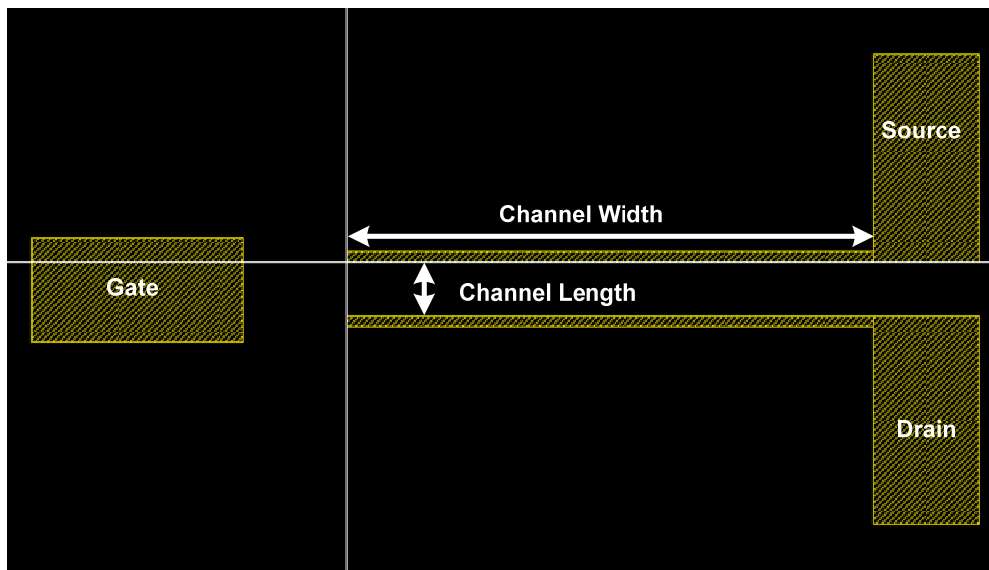


Fig. 3.3.2 Metal pattern of a CNT-OTFT

### B. CNT Channel

Select CNT\_TFT (drw) from LSW window, and draw a rectangle of 500um x 120um, covering the entire two source/drain electrodes and filling the entire 50um gap to form a channel.

### C. CNT Dummy Channel Layer

Since CNT TFTs are modeled as a P-type and a N-type TFT connected in parallel, a dummy channel layer is required to represent the N-type device model (the CNT channel layer in Step B represents the P-type device). Select CNT\_TFT\_DUM (drw) from LSW window, and draw a rectangle of 500um x 120um, exactly overlapping with the CNT\_TFT layer in Step B.

**D. Ion-Gel Dielectric**

Select IONGEL\_TFT (drw) from LSW window, and draw a rectangle of 700um x 120um, completely enclosing the CNT channel, with 25um extension on the length direction and 50um extension on the width side onto METAL1.

**E. PEDOT Conductive Layer**

Select PEDOT\_TFT (drw) from LSW window, and draw a rectangle of 675um x 25um, placed roughly in the middle of the channel. Locate the rectangle so that it extends onto METAL1 over Iongel layer on the gate side by 50um. Iongel layer should also enclose this PEDOT layer by 25um on the right side.

**F. Contact**

For LVS purpose, dummy contacts are required in layout. Select COTFT (drw) from LSW window and draw rectangles at source (CNT overlapping METAL1), drain (CNT overlapping METAL1). Select CONTACT (drw) from LSW window for rectangles at gate (PEDOT overlapping METAL1 but not interacting with IONGEL).

**G. Substrate**

For LVS purpose, substrate layer is required in layout. Select SUB (drw) from LSW window and draw a rectangle to enclose everything.

The final layout should be like this:

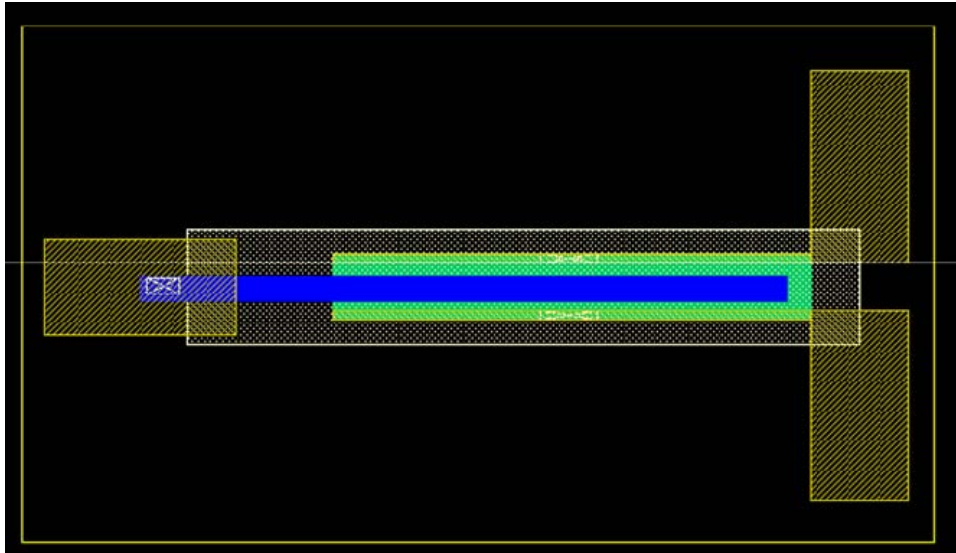


Fig. 3.3.3 Final layout of a CNT-OTFT

## **Chapter 4**

# **Designing Layout of Passive Devices**

This chapter provides details about designing layouts for the supported Passive devices.

---

Supported Passive Devices

Layout of Resistor

Layout of Capacitor

## 1. Supported Passive Devices

The supported passive devices in this OPDK include resistor and TFT-based capacitor, provided by Dr. Frisbie's group in Chemical Engineering and Material Science Department at the University of Minnesota.

Three resistor types are supported:

Resistor with unit resistance of 2k Ohm; and

Resistor with unit resistance of 10k Ohm; and

Resistor with unit resistance of 100k Ohm

Corresponding device symbols:

OPDK\_Devices/res/symbol

Resistor value = Unit Resistance \* L / W (length units: um)

One capacitor type is supported:

TFT-based capacitor with unit capacitance of 100pF

Corresponding device symbols:

OPDK\_Devices/cap/symbol

Capacitance value = Unit capacitance \* W \* L (length units: um)

## **2. Layout of Resistor**

**Note:** There are three types of resistor layers, with different unit resistance. Please choose the appropriate one according to the resistor value you are going to use.

### **A. METAL1**

OEDK provides three types of resistor layers: PEDOT\_R2K, PEDOT\_R10K and PEDOT\_R100K. The resistor value is calculated by  $L/W * R\_Unit$ , where  $R\_Unit$  value is the suffix of each type of layer.

Assume we are going to draw a 10K resistor with PEDOT\_R2K. L/W ratio should be 5 according to the calculation. So here we can go with  $L/W=500\mu\text{m}/100\mu\text{m}$ .

Select METAL1 from LSW window, and draw two rectangles of  $300\mu\text{m} \times 100\mu\text{m}$ , being  $500\mu\text{m}$  away from each other in Y-direction.

### **B. Resistor**

Select PEDOT\_R2K (drw) from LSW window and draw a rectangle of  $100\mu\text{m} \times 700\mu\text{m}$ , extending onto METAL1 layers by  $100\mu\text{m}$  each.

### **C. Substrate**

Select SUB (drw) from LSW window and draw a rectangle to enclose everything.



The final layout should look like this:

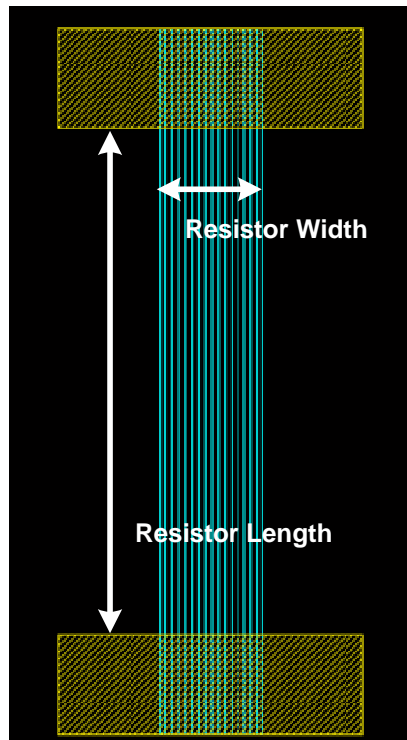


Fig. 4.2.1 Final layout of a resistor

### 3. Layout of Capacitor

**Note:** The capacitor supported in this design kit is formed in the way of a PTFT with P3HT-channel. Therefore, it has positive (drain and source) and negative (gate) ends.

#### A. METAL1

In the LSW window, choose METAL1 (drw). From the Layout window, choose

*Create->Shape->Rectangle*

1. Draw the positive end. Assume we are going to draw a TFTCAP of 2uF. Since the unit capacitance is 10pF/(sq um), we can use  $W/L = 500\text{um}/400\text{um}$ . Draw a rectangle of 500um x 500um, and draw another of 550um x 100um, placed on top of the first one, overlapping 100um in Y direction. Thus only 500um x 400um is going to be used as the capacitor plate.
2. Draw the negative end. Draw a rectangle of 550um x 100um, placed under the 500um x 500um one, with 100um distance away in Y direction.

The final pattern should look like this:

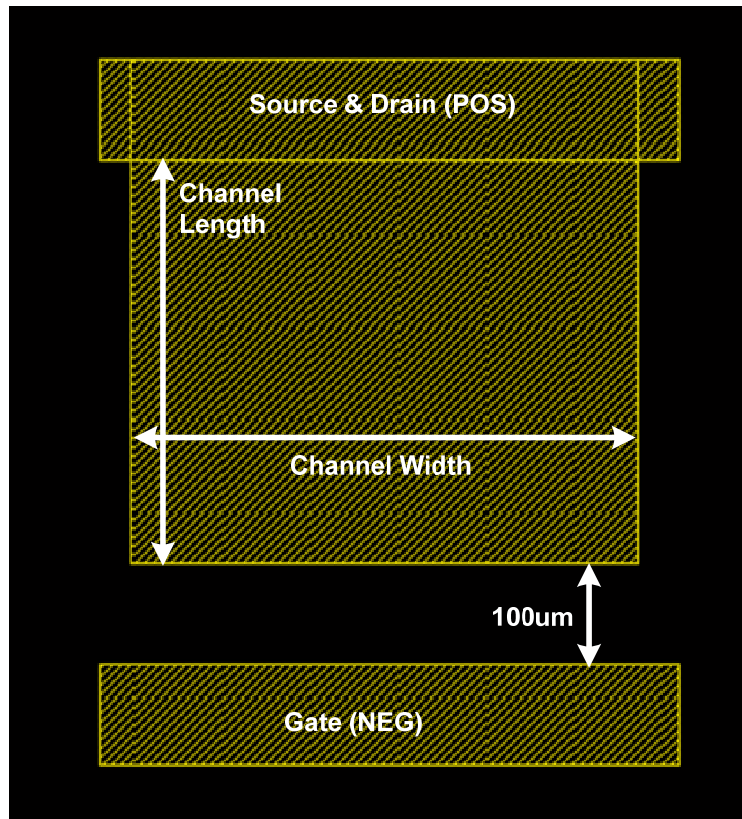


Fig. 4.3.1 Metal pattern of a capacitor

### B. P3HT Channel

Select P3HT\_CAP (drw) from LSW window, and draw a rectangle of 500um x 400um, covering the entire 500um x 400um METAL1 plate. This is the dielectric layer of the TFTCAP.

### C. Ion-Gel Dielectric

Select IONGEL\_CAP (drw) from LSW window, and draw a rectangle of 600um x 500um, completely enclosing the P3HT plate, with 50um extension on four edges.

### D. PEDOT Conductive Layer

Select PEDOT\_CAP (drw) from LSW window, and draw a rectangle of 500um x 600um, completely enclosing the P3HT plate, and overlapping with the negative end with 100um.

**E. Contact**

For LVS purpose, dummy contacts are required in layout. Select CONTACT (drw) from LSW window and draw a rectangle at negative end (PEDOT overlapping METAL1).

**F. Substrate**

For LVS purpose, substrate layer is required in layout. Select SUB (drw) from LSW window and draw a rectangle to enclose everything.

The final layout should be like this:

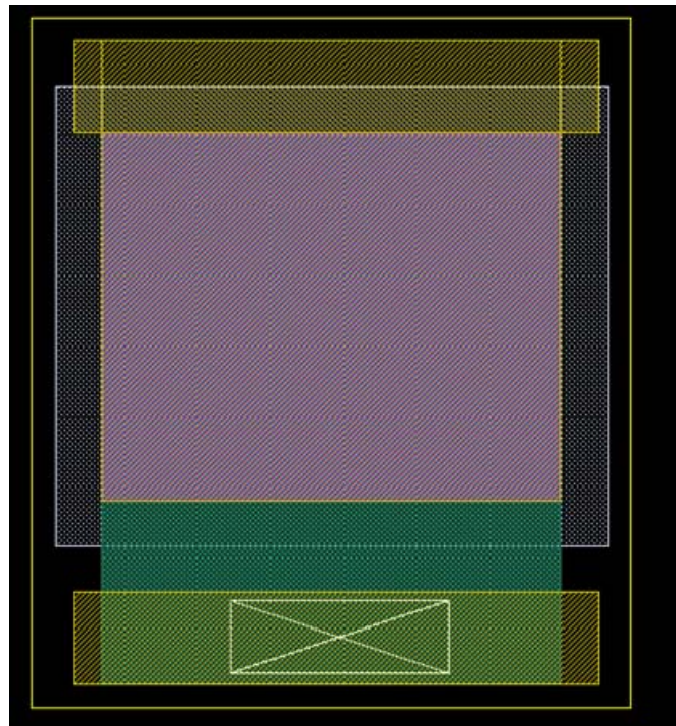


Fig. 4.3.2 Final layout of a capacitor

## **Chapter 5**

# **Applying Cross-Overs for Interconnection**

This chapter provides details about designing layouts for cross-over.

---

Introducing Cross-Over

Layout of Cross-Over

## **1. Introducing Cross-Over**

In circuit designs, it is rare that a single layer of interconnection would be enough. Circuits usually require interconnections to cross each other without being connected (e.g. inputs in a 3-input NAND gate). In modern silicon technology, multiple metal layers are used to provide more routing flexibility, which are connected through vias. In the OTFT platform, however, it is difficult to generate vias during printing. Therefore, cross-overs are used instead.

A cross-over is mainly composed of an insulation layer (PMMA) and a conducting layer (PEDOT). When a metal line A is to cross over another line B without getting connected, we first break A at the position it meets B. We then place a patch of insulation layer (PMMA) over B at the crossing position, and build a bridge over this patch with the conducting layer (PEDOT). The conducting layer will connect the endpoints of broken A and achieve the target.

This cross-over solution can handle any interconnection situations. Sometimes you may combine single cross-overs to save space or to minimize printing effort.

## **2. Layout of Cross-Over**

### **A. METAL1**

Crossover connects two METAL1 pieces together, jumping over another METAL1 piece between them. Assume we are going to connect two METAL1 pieces 300um away from each other.

### **B. PMMA Insulation Layer**

Select PMMA (drw) from LSW window and draw a rectangle of 200um x 300um, completely enclosing the METAL1 piece in the middle by 50um on four edges.

### **C. PEDOT Conductive Layer**

Select PEDOT\_CRV (drw) from LSW window and draw a rectangle of 100um x 400um, placed over the METAL1 piece in the middle and extending onto the two METAL1 pieces to connect by 50um.

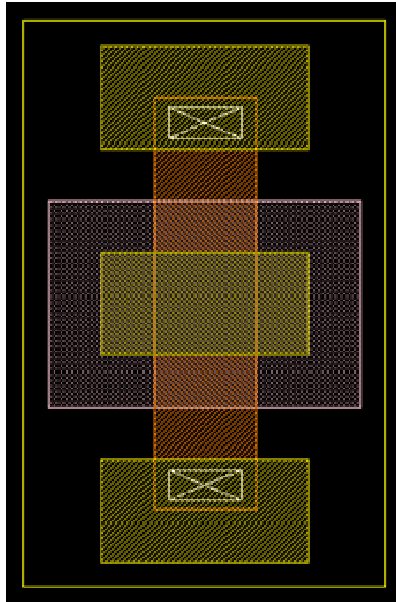
### **D. CONTACT**

For LVS purpose, dummy contacts are required in layout. Select CONTACT (drw) from LSW window and draw rectangles on two sides where PEDOT overlaps METAL1.

### **E. Substrate**

For LVS purpose, substrate is required in layout. Select SUB (drw) from LSW window and draw a rectangle to enclose everything.

The final layout should look like this:



**Fig. 5.2.1 Final layout of a cross-over**



## **Chapter 6**

### **Using P-Cells**

This chapter introduces how to use P-Cells to facilitate layout design.

---

Purpose of P-Cell

Supported Devices

Using P-Cell for Ion-Gel-Top-Gated P3HT-Channel OTFT

Using P-Cell for Ion-Gel-Top-Gated CNT-Channel OTFT

Using P-Cell for Capacitor

## **1. Purpose of P-Cell**

P-Cell stands for parameterized cell. Cells that only vary in parameters can be grouped with the concept of P-Cell and thus significantly reduce work load. The single OTFT device symbols that we use in Chapter 2 can also be viewed as a P-Cell, since by specifying parameters, various devices can be obtained.

P-Cells can be very useful in layout design. If two devices are different only in parameters, it would be much more efficient to generate the second device based on the first one, instead of designing from scratch.

So the basic concept of P-Cell is: first, create a reference layout for a single type of device; then specify parameters, and the software will stretch the reference layout according to the parameter difference. Thus, devices with various parameters can be generated with little effort, which significantly improve design efficiency.

## **2. Supported Devices**

The supported devices in this OPDK with P-Cell setup include ion-gel-top-gated OTFTs with P3HT or CNT channel layer, and TFT-based capacitor, provided by Dr. Frisbie's group in Chemical Engineering and Material Science Department at the University of Minnesota.

Corresponding OTFT device symbols:

OPDK\_Devices/PTFT\_P3HT\_TG/symbol

OPDK\_Devices/CHT\_TFT\_TG/symbol

Corresponding capacitor symbols:

OPDK\_Devices/cap/symbol

## 3. Using P-Cell for Ion-Gel-Top-Gated P3HT-Channel OTFT

### 3.1 Create an Instance with P-Cell

Create a new instance in your layout:

Create -> Instance

Select layout view in OPDK\_Pcells/PTFT\_P3HT\_TG/layout

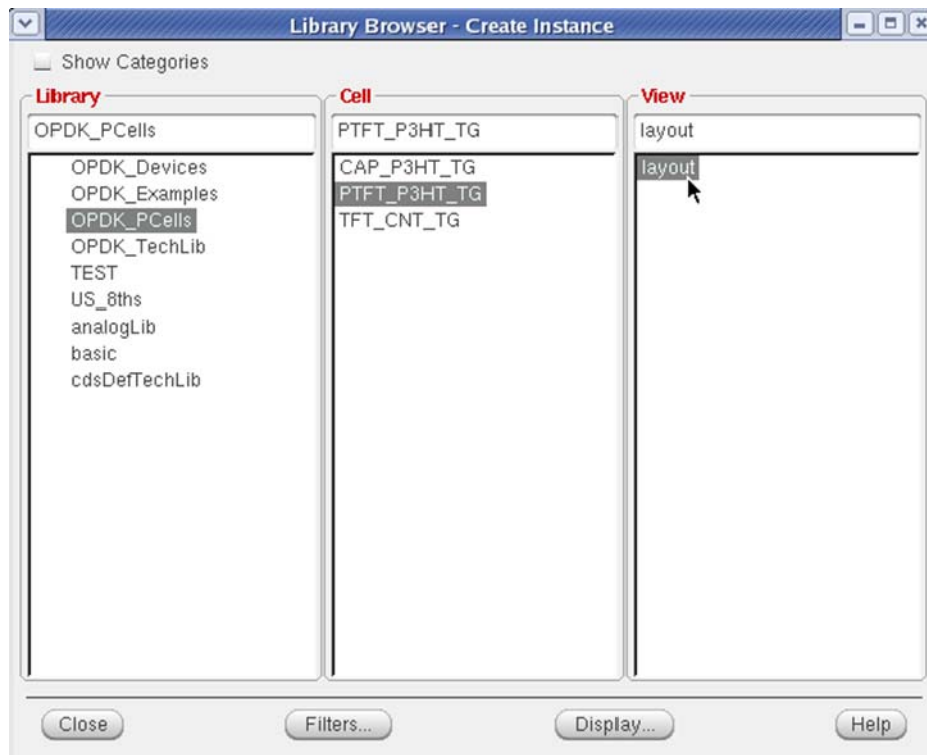
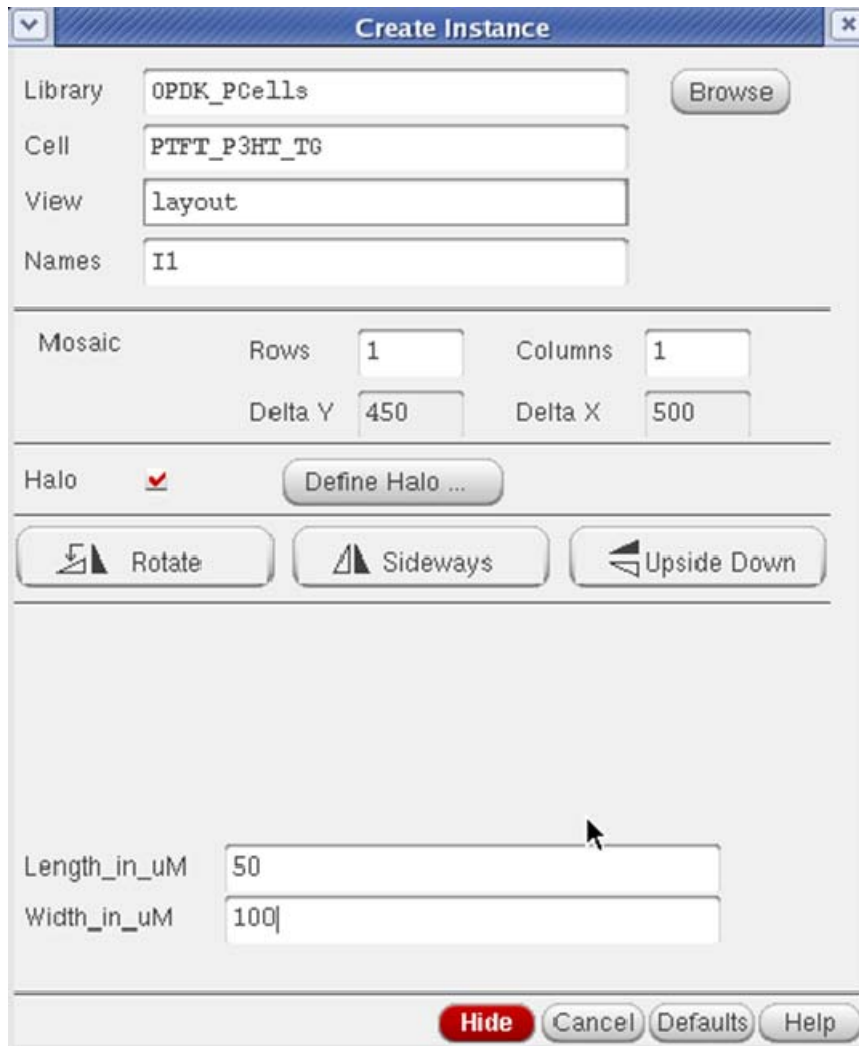


Fig. 6.3.1 Utilizing P3HT-OTFT P-Cell to create device layout

### 3.2 Specify key parameters

Assume we are creating a PTFT\_P3HT\_TG device with  $W/L = 100\mu\text{m} / 50\mu\text{m}$ . In the bottom of the Create Instance window, specify Length\_in\_uM as 50 and Width\_in\_uM as 100.



**Fig. 6.3.2 Specify channel length and width for P3HT-OTFT**

Note: usually the default parameters are the minimum values. If an invalid value is specified, it will restore its previous value. To make sure, click on another input textbox and check if the input value is restored.

### **3.3 Place the instance**

Place the new instance at appropriate position in your layout view.

## 4. Using P-Cell for Ion-Gel-Top-Gated CNT-Channel OTFT

### 4.1 Create an Instance with P-Cell

Create a new instance in your layout:

Create -> Instance

Select layout view in OPDK\_Pcells/TFT\_CNT\_TG/layout

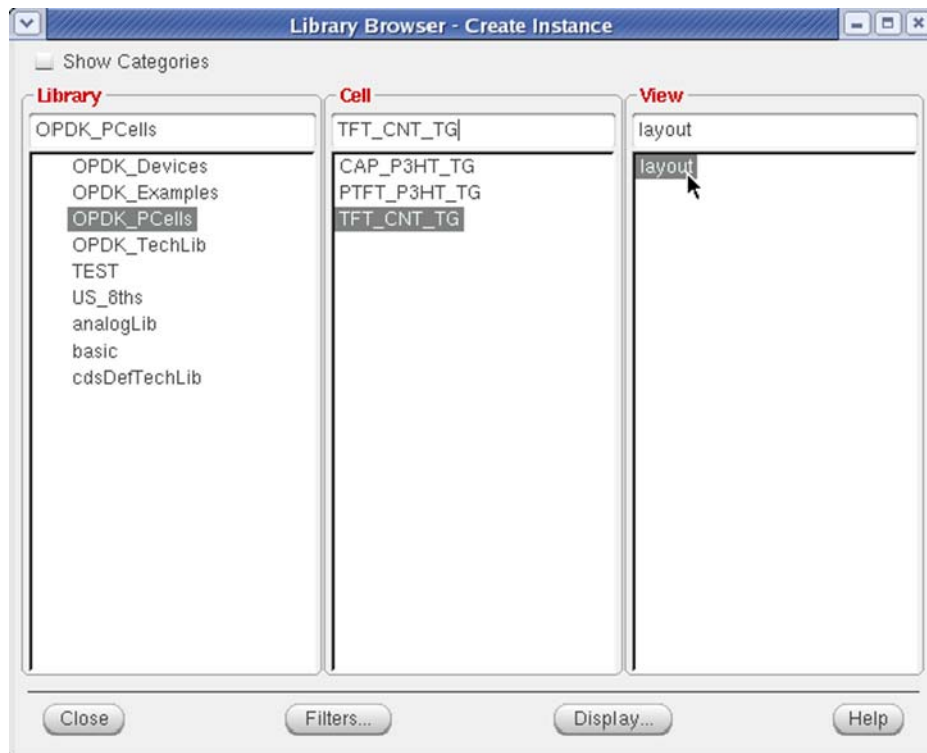
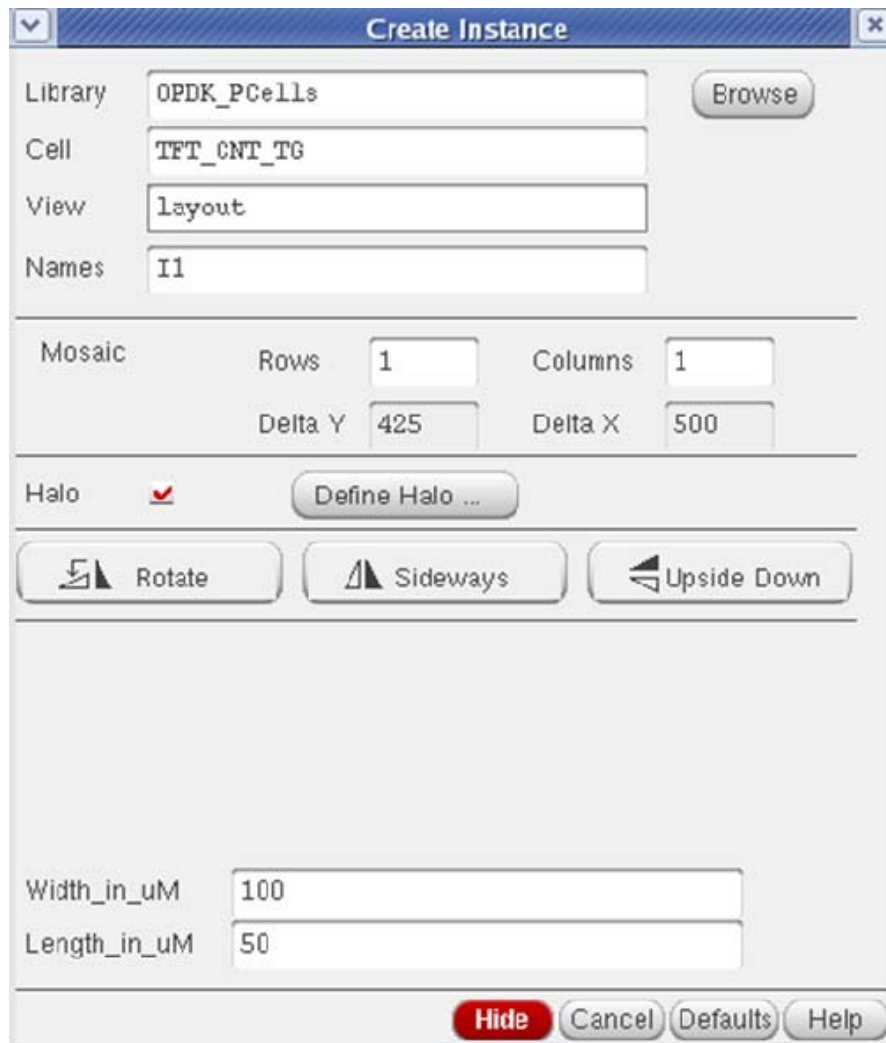


Fig. 6.4.1 Utilizing CNT-OTFT P-Cell to create device layout

### 4.2 Specify key parameters

Assume we are creating a TFT\_CNT\_TG device with W/L = 100um / 50um. In the bottom of the Create Instance window, specify Length\_in\_uM as 50 and Width\_in\_uM as 100.



**Fig. 6.4.2 Specify channel length and width for CNT-OTFT**

Note: usually the default parameters are the minimum values. If an invalid value is specified, it will restore its previous value. To make sure, click on another input textbox and check if the input value is restored.

### **4.3 Place the instance**

Place the new instance at appropriate position in your layout view.

## 5. Using P-Cell for Capacitor

### 5.1 Create an Instance with P-Cell

Create a new instance in your layout:

Create -> Instance

Select layout view in OPDK\_Pcells/CAP\_P3HT\_TG/layout

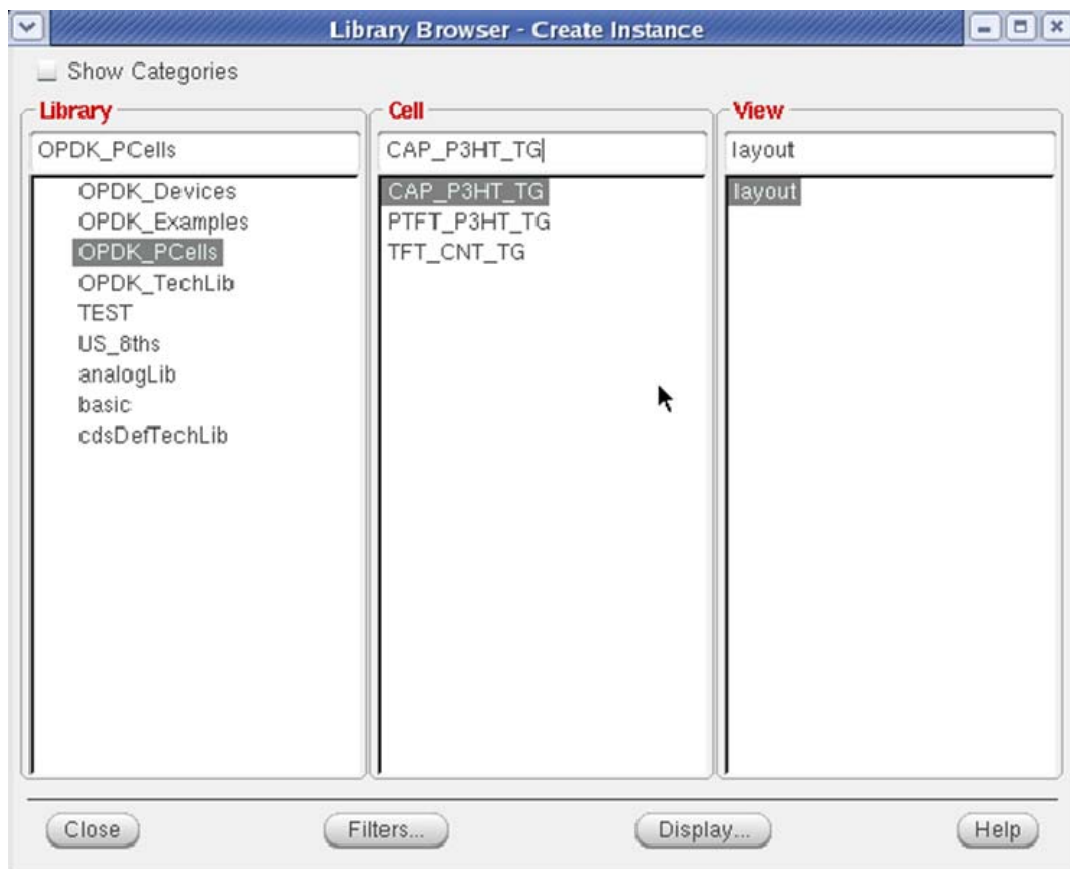
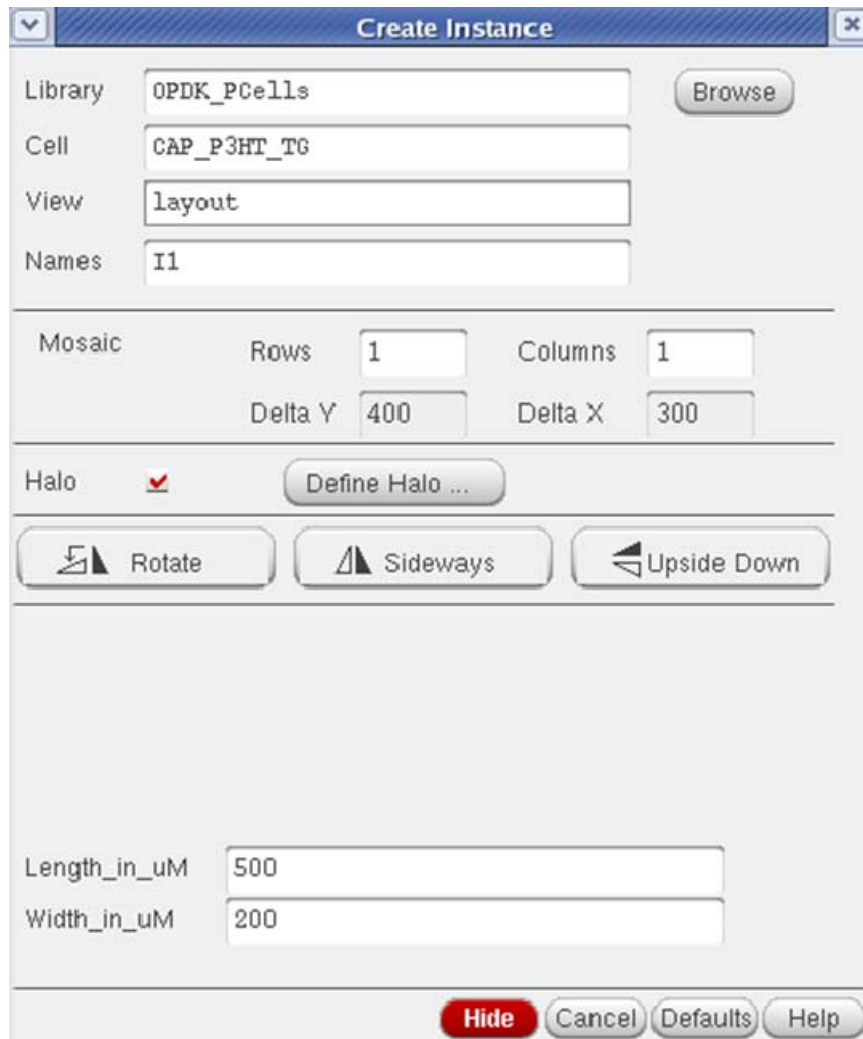


Fig. 6.5.1 Utilizing capacitor P-Cell to create device layout

### 5.2 Specify key parameters

Assume we are creating a CAP\_P3HT\_TG device with area of  $W*L = 200\mu\text{m} / 500\mu\text{m}$ . In the bottom of the Create Instance window, specify Length\_in\_uM as 500 and Width\_in\_uM as 200.





**Fig. 6.5.2 Specify channel length and width for capacitor**

Note: usually the default parameters are the minimum values. If an invalid value is specified, it will restore its previous value. To make sure, click on another input textbox and check if the input value is restored.

### **5.3 Place the instance**

Place the new instance at appropriate position in your layout view.

## **Chapter 7**

# **Simulating Circuits**

This chapter provides the basic steps of simulating circuits with device models.

---

Introducing Device Models

Simulating with HSPICE

## 1. Introducing Device Models

Device models include detailed characteristics of the device, which are utilized in simulation. In OPDK we focus on HSPICE models. Due to the similarity in I-V characteristics of OTFT and silicon transistors, compact models are feasible by modeling OTFTs with traditional silicon transistors. In OPDK, OTFT with P3HT channel is modeled as a PMOS transistor, and OTFT with CNT channel is modeled as a PMOS transistor and a NMOS transistor connected in parallel. Resistor and capacitor are modeled as ideal resistor and capacitor, respectively. The model parameters are selected to fit the real I-V curves obtained from measurements.

Another approach is to utilize behavior modeling. It is basically a look-up table. Once the raw I-V curve is obtained, users can directly use the measurement data to build the look-up table, or say, behavior device model. This way is more straightforward and requires little curve fitting effort; however, errors in measurement could introduce potential risks as convergence failures, and the simulation cannot exceed the voltage range of the table. The models included in OPDK do not involve this approach.

TFT capacitance can be estimated by data fitting with measurements of ring oscillator frequency. To simulate timing parameters, the estimated capacitance should be added to the model, either by assigning the unit capacitance values in the compact model (e.g. Cgdo), or by adding an explicit capacitor to the device.

## 2. Simulating with HSPICE

To simulate the circuit in HSPICE, you need to first generate the circuit file (netlist) and prepare the model files needed.

### 2.1 Launch Analog Design Environment (ADE)

In your schematic window, launch Analog Design Environment (ADE):

Launch -> ADE L...

A window will pop out.

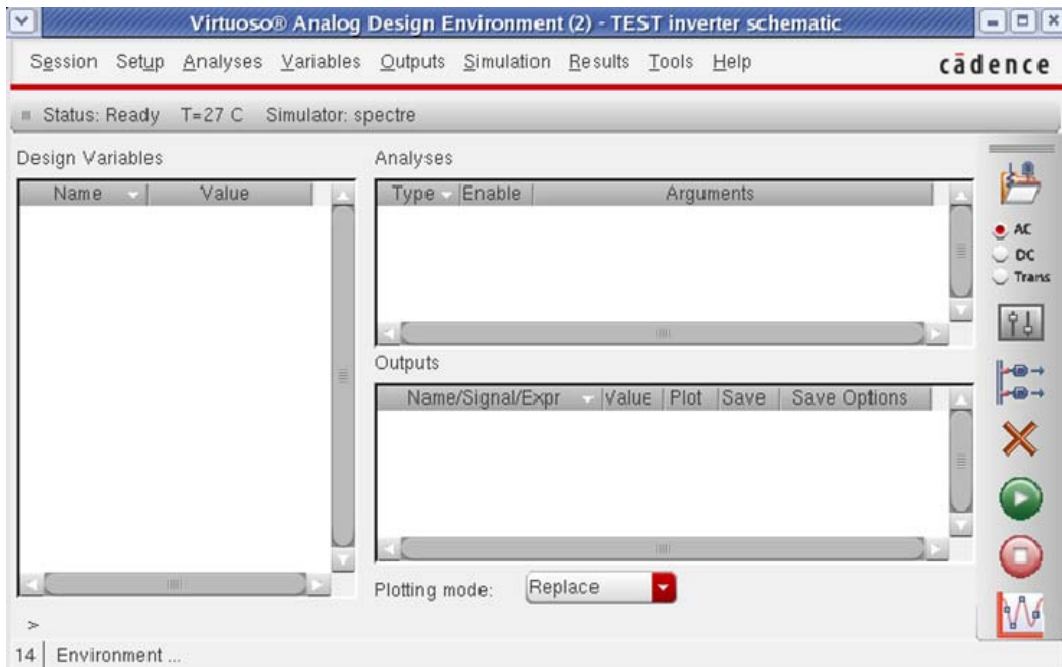


Fig. 7.2.1 Virtuoso ADE interface

### 2.2 Set up Simulator

Click Setup -> Simulator/Directory/Host ...

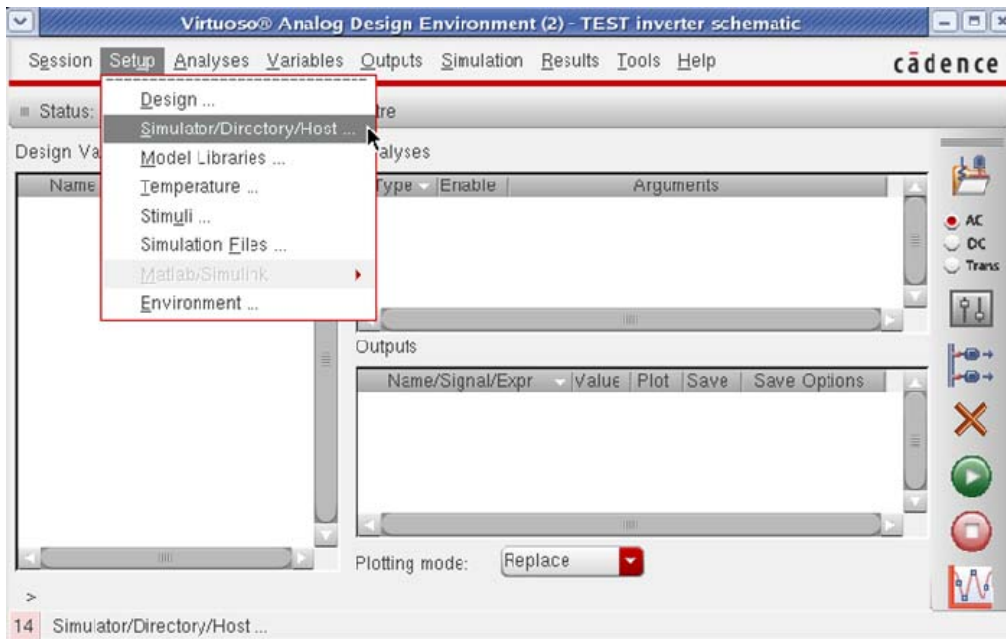


Fig. 7.2.2 Set up simulator

Select hspiceD in Simulator. Click OK to return.

### 2.3 Generate Circuit Netlist File

Click Simulation -> Netlist -> Create

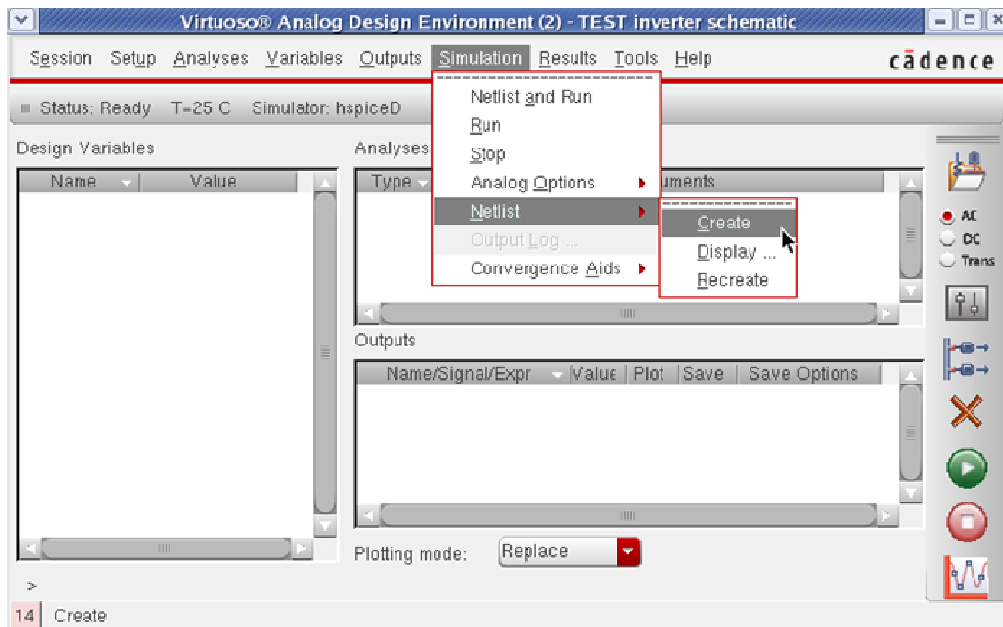


Fig. 7.2.3 Create netlist

The following window will pop out, displaying the generated netlist.

```

** Generated for: hspiceD
** Generated on: Dec 14 22:21:00 2010
** Design library name: TEST
** Design cell name: inverter
** Design view name: schematic

.TEMP 25
.OPTION
+   ARTIST=2
+   INGOLD=2
+   PARHIER=LOCAL
+   PSF=2

** Library name: TEST
** Cell name: inverter
** View name: schematic
m0 out in vdd sub PTFT_P3HT_TG L=50e-6 W=500e-6
r0 out gnd 10e3
.END

```

**Fig. 7.2.4** Generated netlist

Click File -> Save As... and save the netlist file as your HSPICE netlist, e.g. test.sp.

## **2.4 Include Model File**

Open the netlist file saved in 2.3, e.g. test.sp. Add the model path before the circuit descriptions:

```

...
+   PSF=2

.inc "/models/model_P3HT"

** Library name : TEST
...

```

Make sure your model file path is correct.

## 2.5 Modify Simulation File

Make necessary modifications to your simulation file, including simulation options, power supply, inputs, analysis type, etc. The following is an example to simulate the inverter for its transfer curve.

```
** Generated for: hspiceD
** Generated on: Dec 14 22:21:00 2010
** Design library name: TEST
** Design cell name: inverter
** Design view name: schematic

.TEMP 25      $Simulation Temperature
.OPTION      $Simulation Options

+ ARTIST=2
+ INGOLD=2
+ PARHIER=LOCAL
+ PSF=2
+ POST =2

.inc “./OPDK/organic_basekit/models/model_P3HT” $Included Model File
** Library name: TEST                      $Circuit Description
** Cell name: inverter
** View name: schematic

m0 out in vdd sub PTFT_P3HT_TG L=50e-6 W=500e-6
r0 out gnd 10e3

VDD vdd 0 1.2      $Power Supply
VGND gnd 0 0
```

```
VSUB sub 0 1.2
VIN in 0          $Input
.dc VIN 0 1.2 0.01 $Analysis Type: DC Sweep
.END
```

## 2.6 Run Simulation

At the directory where you save your test.sp, run hspice:

```
hspice test.sp
```

You should be able to see “job concluded” near the bottom of the simulation log printed on screen. In case of “job aborted”, check your test.sp file.

## 2.7 Examine Waveform

Now you can observe your waveforms generated by the simulation. For example, you can launch escope and open the test.sw0 file. Select v(out) and the waveform should look like this:

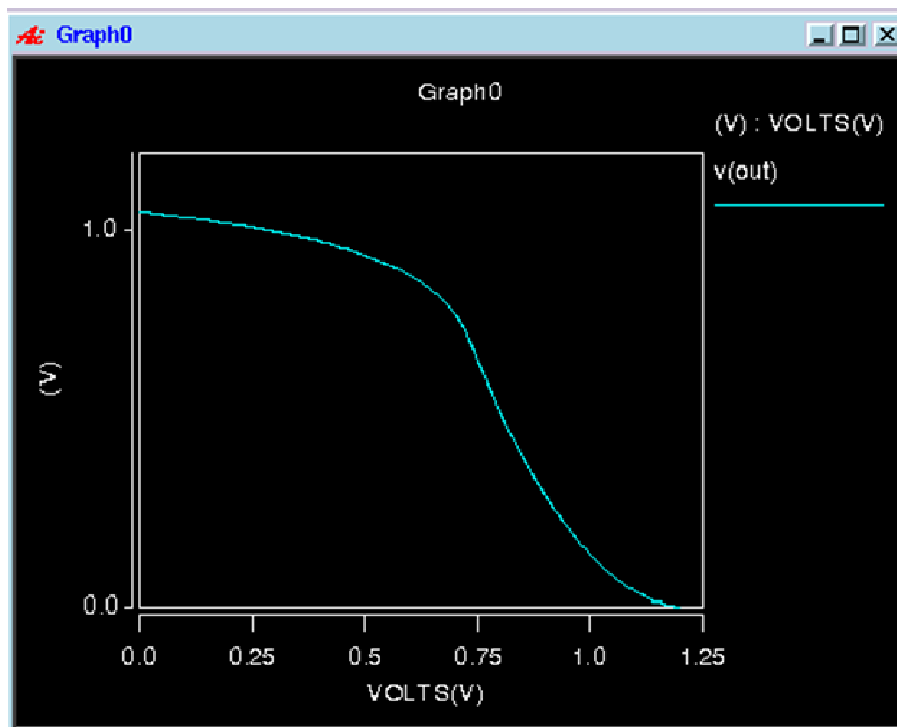


Fig. 7.2.5 HSPICE simulation waveform